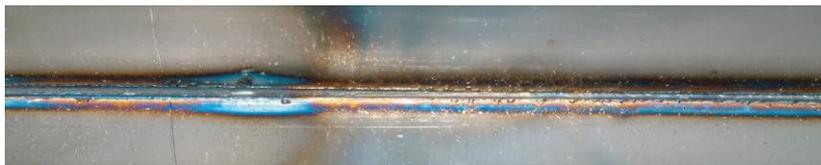




# PLANS FOR EXPERIMENT PROTECTION AT LHC



- ❑ Introduction:
  - Lessons from the past
  - The **L**arge **H**adron **C**ollider
- ❑ LHC protection strategy
  - Beam interlock system
- ❑ Failure scenarios
  - Risks for the Expts
- ❑ LHC Experiment protection
  - Beam conditions monitors, etc.
- ❑ Detectors damage threshold
  - What do we know for silicon ?
- ❑ Conclusion and outlook



❑ Note: I won't address heavy ion beams

Special thanks to:

- ❑ Antonello di Mauro, Siegfried Wenig, Richard Hall-Wilton, Richard Jacobsson, Jorg Wenninger, Rudiger Schmidt, Rob Appleby, Daniela Macina, etc.

- ❑ Sp $\bar{p}$ S:
  - 198x: electrostatic separators adjusted for 315 GeV, instead of injection energy of 26 GeV  
=> UA2 gets beam injected **repeatedly** into detector, no fast feedback from the Expt
- ❑ LEP:
  - 1991: Quad polarity switched... **consecutive splashes** into L3, damage to BGO lumimonitor (later, in 1992, further failures with damage to endcap calorimeter...)
  - 1993: Quad failure ... Aleph loses fraction of VDET due to shorting of AC capacitor chips
- ❑ RHIC:
  - 2000: Phobos: **several missed aborts**, lose 1-2% of their Si pad detector channels (other RHIC experiments affected as well).
- ❑ HERA:
  - 2002: damage caused to H1 Si pad and strip detectors (BST) and their electronics.
- ❑ Tevatron:
  - 2002: asynchronous dump, CDF loses six ladders of vertex detector due to chip failure

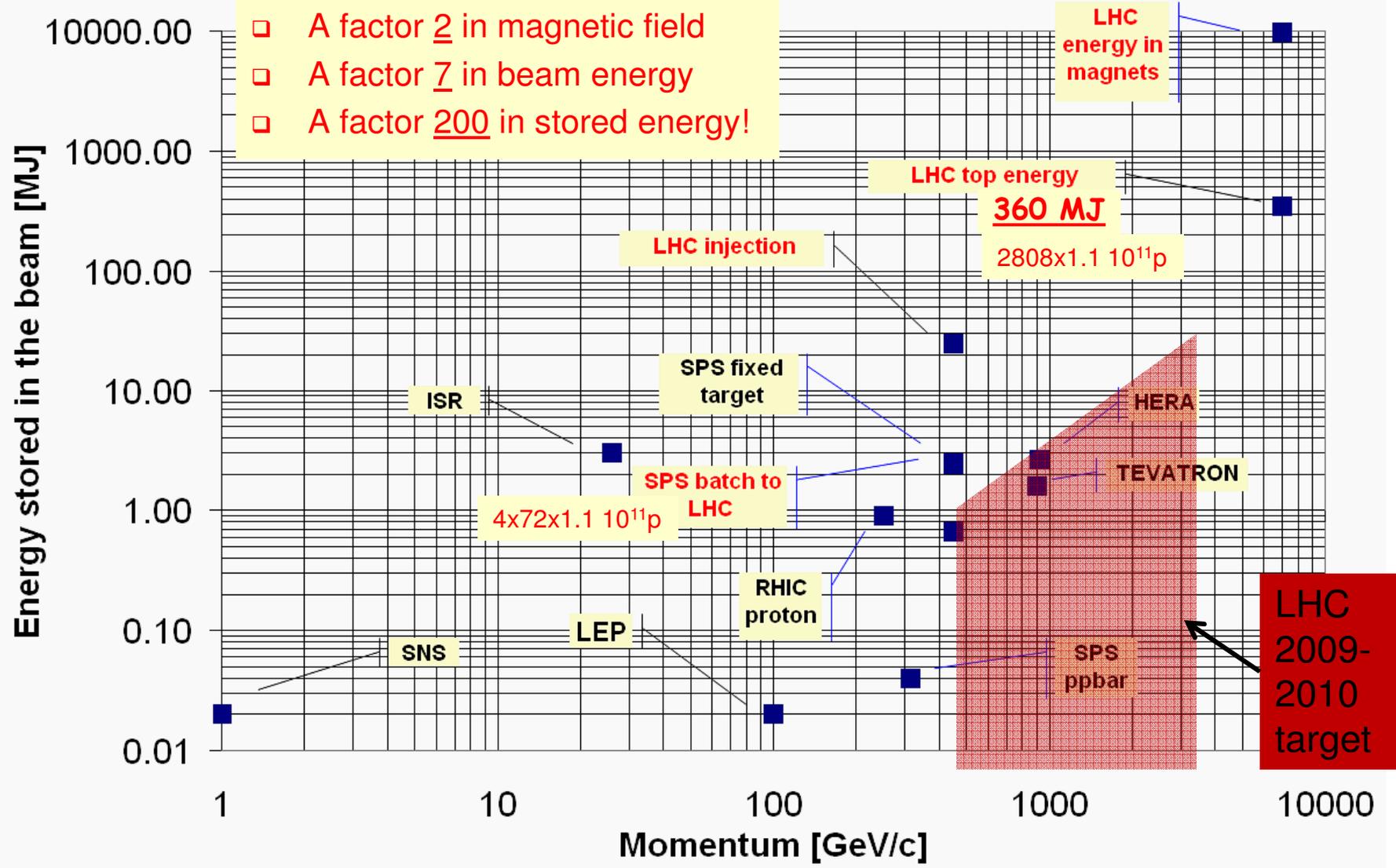
## Lessons:

See J. Spalding in [TeV4LHC](#) April 2005

- ❑ it does happen!
- ❑ better have a protection system in the experiment to trigger beam abort
- ❑ better have *some sort of monitor* during injection (fast feed back to machine!)

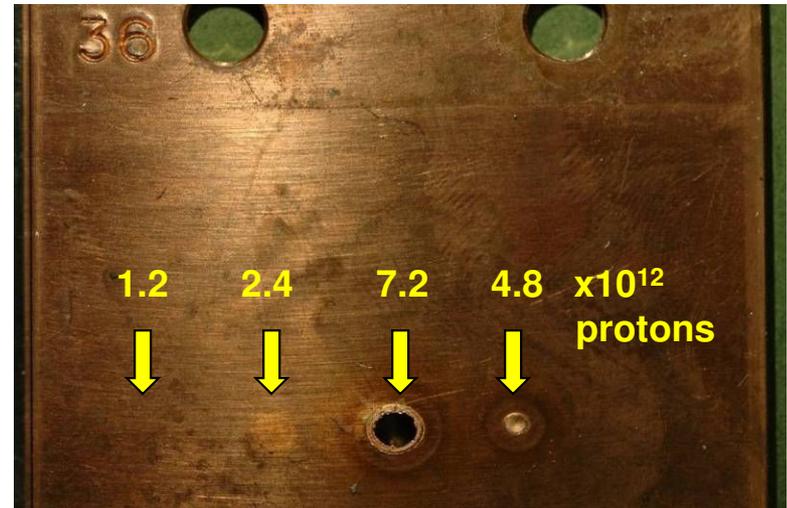


# Stored Energy of the LHC



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- ❑ LHC colleagues performed a controlled experiment with 450 GeV beam shot into a stack target to benchmark simulations.
- ❑ Copper:
  - melting point reached at  $\approx 2.4 \times 10^{12}$  p
  - clear damage at  $\approx 4.8 \times 10^{12}$  p
- ❑ Good agreement with simulation



See V. Kain et al., *Material damage test with 450 GeV LHC-type beam*, Proc. of 2005 Part. Acc. Conf., Knoxville, Tennessee, and PhD Thesis by V. Kain, [CERN-Thesis-2005-047](#)

Definition for the LHC of a “safe” beam limit (setup beam, see later):

$10^{12}$  protons at 450 GeV  $\Rightarrow$  about 3% of a full SPS batch

$10^{10}$  protons at 7 TeV (scaled from 450 GeV)

Note: tests as described above do not correspond to the most typical impact of beam, there is a safety margin on the 450 GeV “safe beam” for typical accelerator equipment. But what about experiments/detectors ?

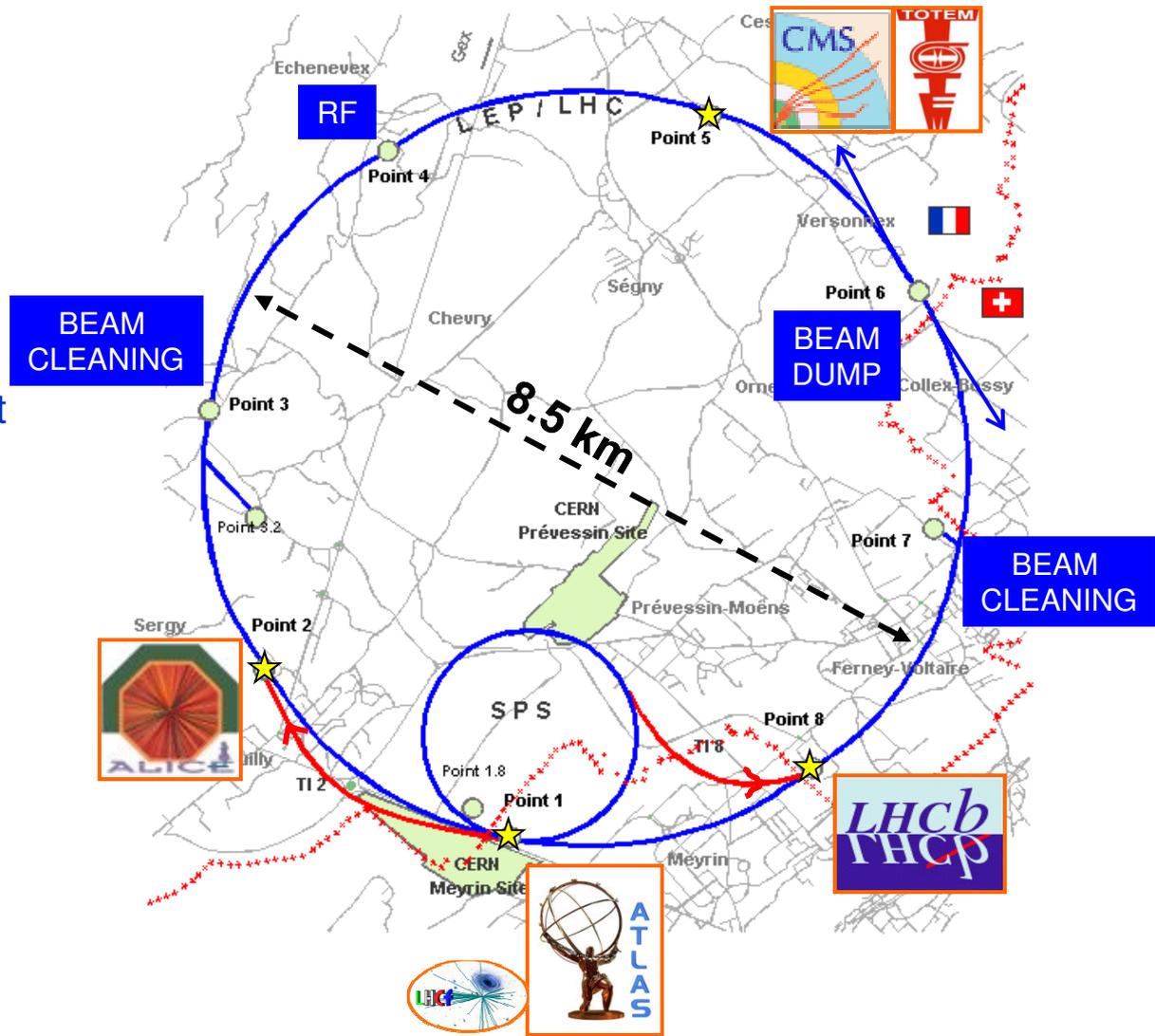


# The LHC and the Experiments



Paris, France  
Topical Workshop on Electronics for Particle Physics  
September 21-25, 2009

- CMS/Totem:
  - near dump
  - roman pots
  
- LHCb and Alice:
  - just near injection point
  - experimental dipole magnets + correctors
  - no TAS absorbers
  - LHCb VELO, similar to "roman pots"
  
- ATLAS/LHCf:
  - a cool place to be...



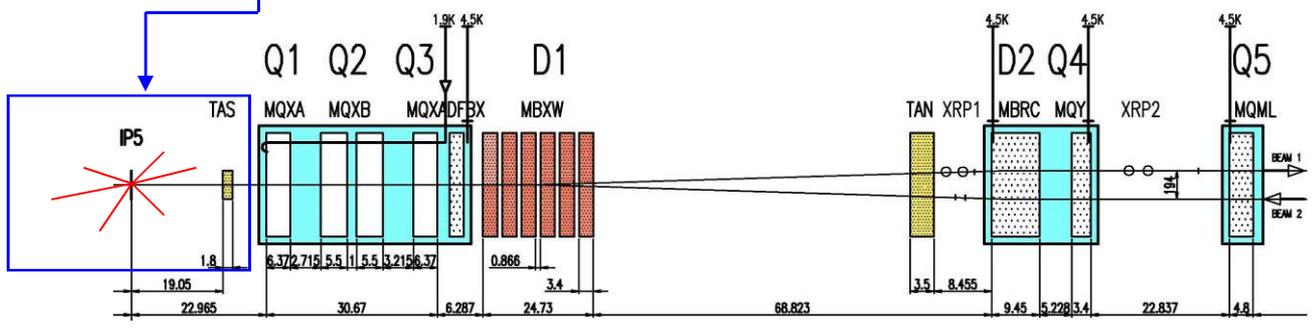
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# Typical Insertion Region ( Region Around Experiment )



Here is CMS (same for ATLAS), symmetric at IP:



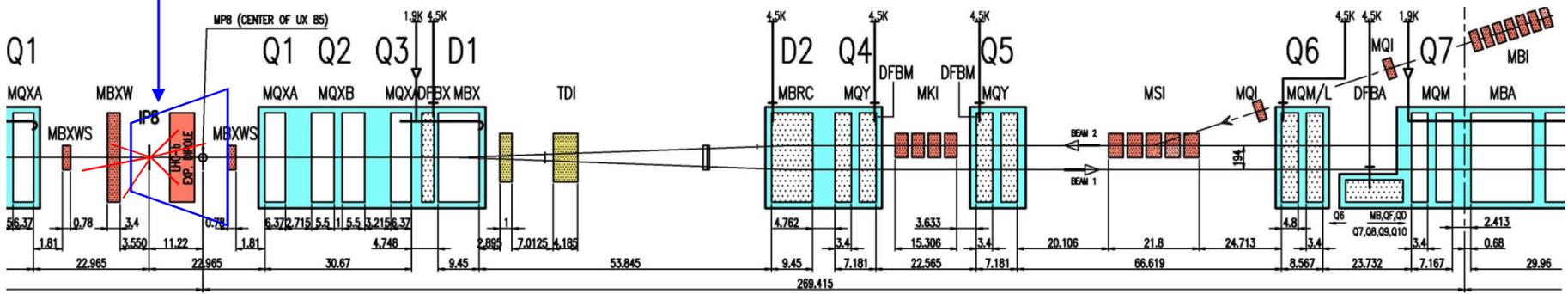
Legend:

- cryomagnet
- warm magnet
- absorber/ collimator

TAS = absorber to protect triplet from IP primaries      NB: Q1-3 contain also some corrector dipoles

Here is LHCb (similar for ALICE):

injection from SPS !



- No TAS
- presence of dipole magnet + correctors MBXW...

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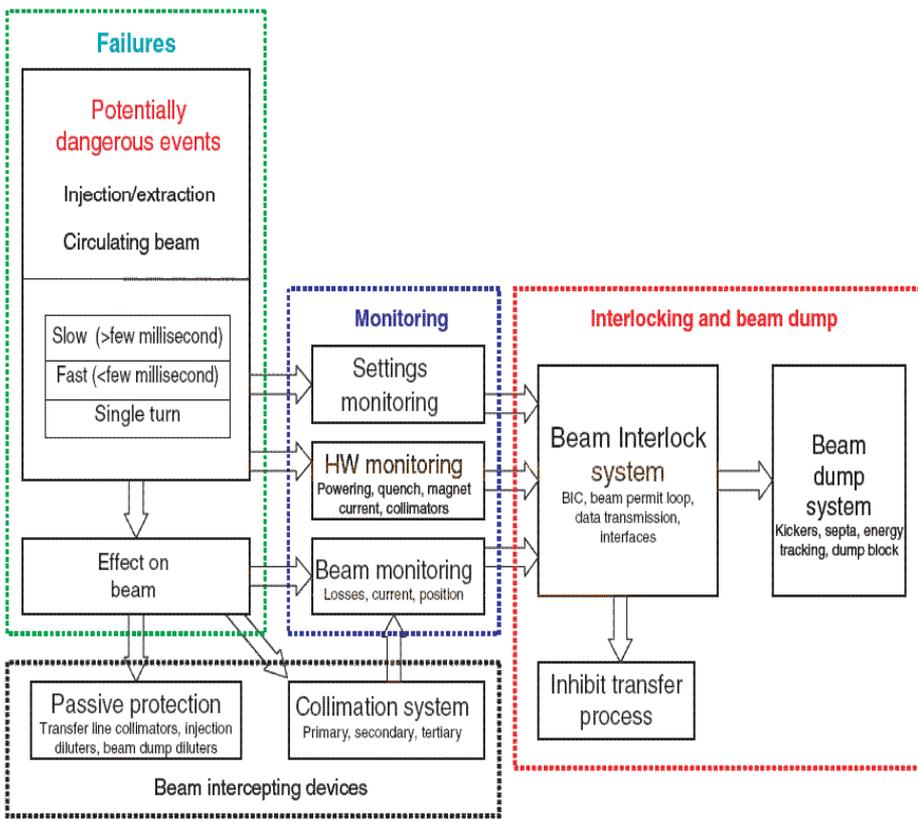


# LHC Machine Protection



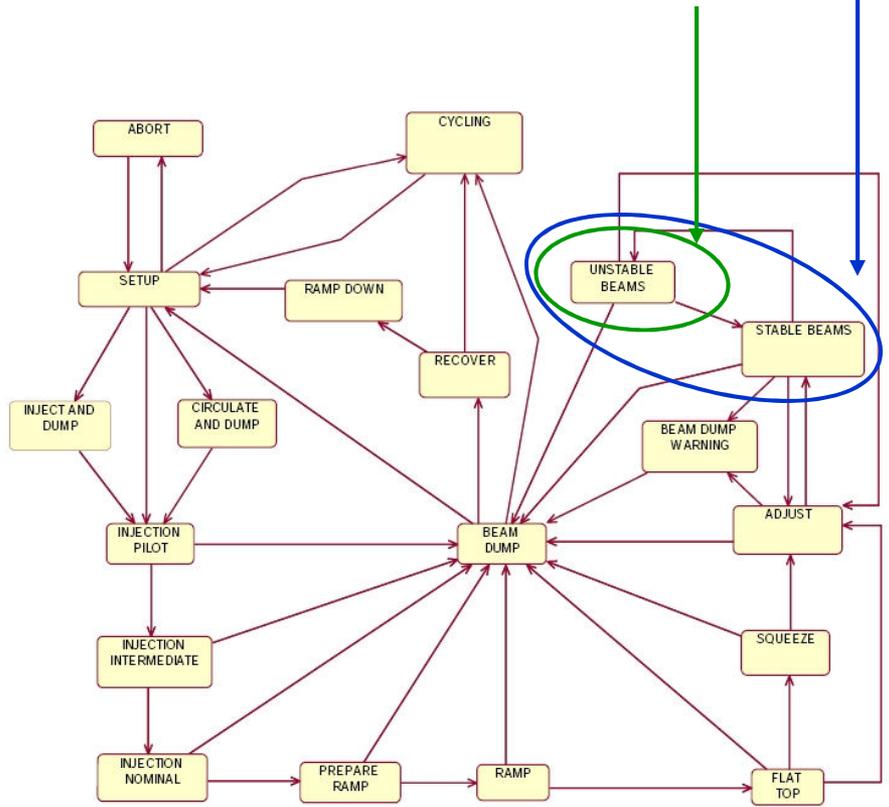
Paris, France  
Topical Workshop on Electronics for Particle Physics  
September 21-25, 2009

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## Beam modes:

- ❑ Outside these two beam modes, movable detectors **must** be OUT
- ❑ In this state, they *should* move OUT (but don't dump if not...)

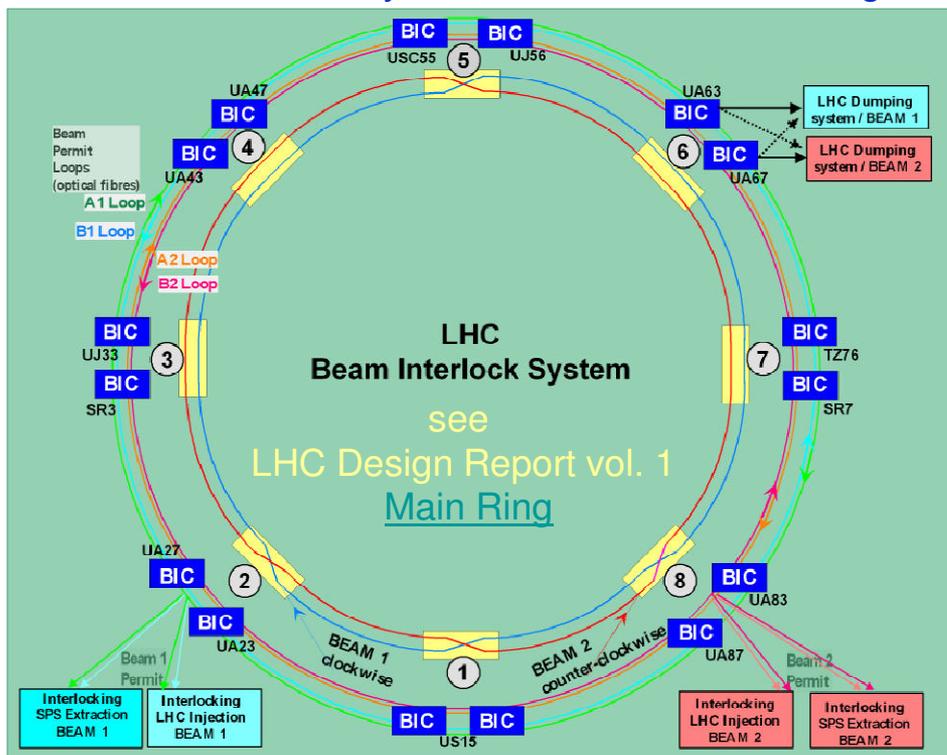




# LHC "Active," Machine Protection : Beam Interlocks

- General strategy:
  - inject probe bunch ( $5 \times 10^9$  p)
  - if OK (circulating), inject higher intensity batch
  - on dump trigger => extract beam in  $< 0.3$  ms (1 turn  $\cong 0.09$  ms)
- Abort gap:
  - continuously monitored, at least 3  $\mu$ s long

- Beam Interlock System
  - Two redundant BeamPermit loops per beam around the ring
  - Beam Interlock Controller:
    - Makes AND of several UserPermit signals
    - More than 3000 LHC user devices of the BICs (BLM's, BPM's, etc.)
    - If UserPermit signal is false, then BeamPermit is false => dump and block injection
- BeamPresence
  - one flag per LHC ring
  - at least 5  $\mu$ A in the ring (fast AC BCT)
- ProbeBeam
  - True if SPS intensity  $<$  limit
    - limit =  $C \times 10^{11}$  protons ( $C \leq 1$ )
  - if BeamPresence and ProbeBeam are false, then cannot inject into LHC
- SetUpBeam
  - based on LHC current, energy dependent:
    - True if  $< 10^{12}$  ( $5 \times 10^{10}$ ) protons at 0.45 (7) TeV.
    - If True, it allows masking some BIS inputs



## For the experiments, these are the worries:



### ❑ Injection failures:

- incomplete or unsynchronized kicker fire => mostly Alice & LHCb
- wrong magnet settings in transfer line => mostly Alice & LHCb
- wrong magnet settings in the LHC => everybody

### ❑ Circulating beam failures: => **mostly caught by collimators**

- magnet failure / mishap => everybody
- RF failure => everybody
- collimator failure / mishap => everybody

} Expect Expts to be protected by "early" cryomagnet quench protection



### ❑ Extraction failures:

- underkick, unsynchronized beam dump => mostly CMS

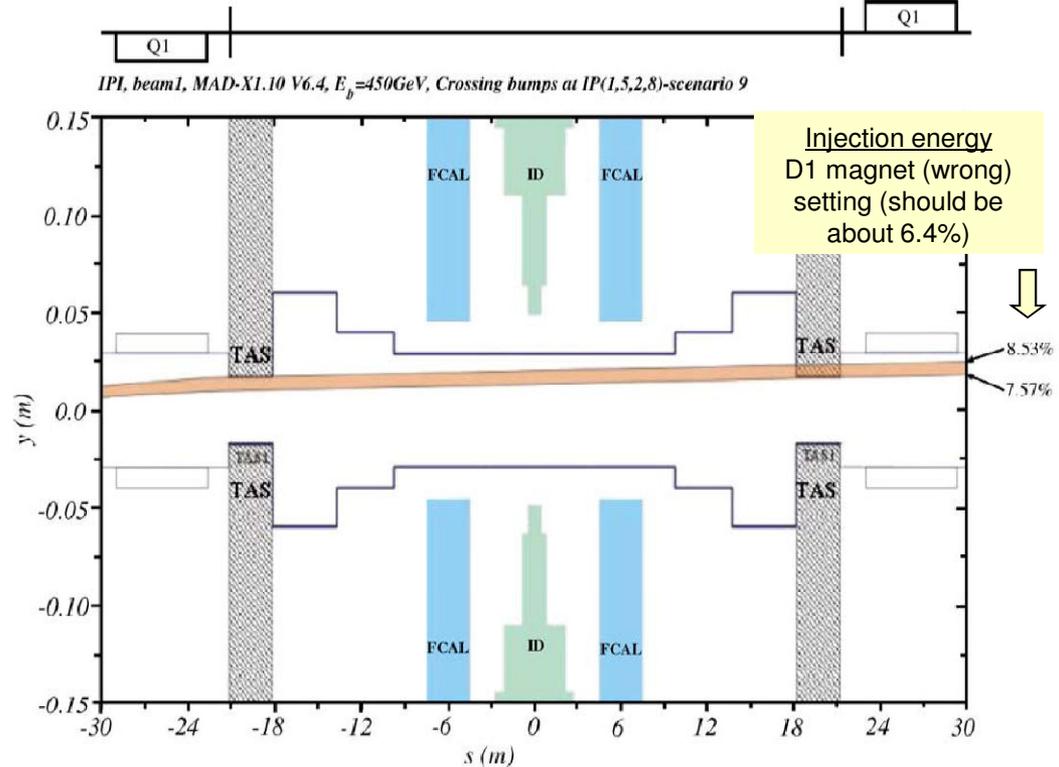
We'll see some specific examples later

- In terms of estimating particle rates to a detector, the only simple (though quite unlikely) LHC failure scenario is
  - Suppose a batch is injected with wrong magnet settings near an experiment (remember: a probe beam has  $< 10^{11}$  protons)
  - The batch is shot straight into the detector without traversing much material (little showering, less than  $\times 10$  multiplication), beam size  $\sigma \sim 0.3$  mm
  - Potentially, of order  $\sim 10^{13}$  p/cm<sup>2</sup> (in  $< 1$  ns) depending on the maximum value for the **ProbeBeam** and on the local shower multiplication
  - Very high flux density, but very local (could be quite catastrophic if readout chips happen to be on the trajectory)
- Other possible failures (with grazing, showering,...) require detailed MC simulations
  - Work in progress
  - A few examples in the next slides

See Dariusz Bocian, LHC Project Note 335

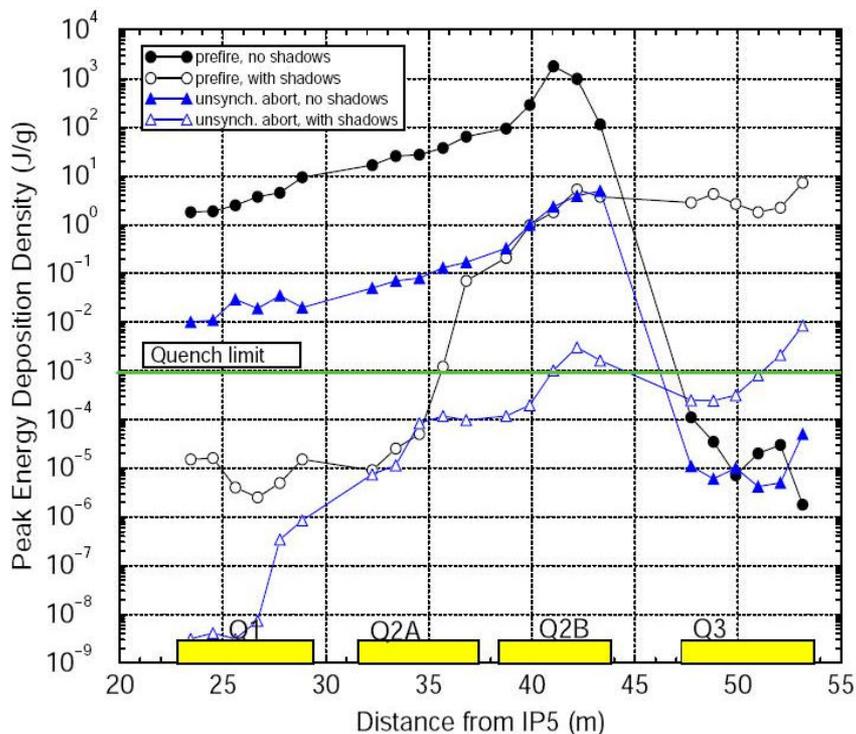
## ATLAS beam failures simulation:

- ❑ Studied wrong settings of MCBX, D1 and D2: due to presence of TAS absorber, **pilot beam can never hit directly the Inner Detector.**
- ❑ Thus, **most dangerous case is when wrong magnet setting is such that beam scrapes first TAS and hits second TAS.**
- ❑ If a  $5 \times 10^9$  bunch is lost in ATLAS due to a single wrongly set magnet, the estimated radiation dose delivered to the b-layer is estimated to be
  - $< 5 \times 10^{-3} \text{ Gy}$  or
  - ( Note: in terms of rate this is about  $10^7$  more than during a nominal bunch crossing, i.e.  $\sim 10^6 \text{ MIP/cm}^2$ )



- ❑ **Specially searched for two-magnet failures** could deposit much more, but such failures are considered much less likely

- Simulations for effect on CMS / IP5 due to unsynchronized abort and kicker prefire, see Drozhdin, Mokhov, Huhtinen, 1999 *Particle Acc. Conference*
  - kicker prefire: one kicker module fires alone; should not happen (system designed such that a firing module fires the other modules)
  - unsynchronized abort: quite likely to happen; kicker rise time  $\sim 3\mu s$   
=>  $\sim 120$  bunches swept



- Results (for Pixel detector):
  - Integrated doses not so dangerous,
  - but rates are!
  - Up to  $10^8$  times higher instantaneous rates than during nominal running  
=> up to  $10^8 \times 10^6 \text{ MIP cm}^{-2} \text{ s}^{-1}$  !!
- These results led to addition of movable and fixed collimators at IP6 (TCDQ, TCDS) to intercept the bulk of the mis-kicked beam

## Effect of kicker failures during injection

- See B. Pastirčák et al., *Radiation from Misinjected Beam to LHC*, ALICE Internal Note 2001-03

### Failure scenarios:

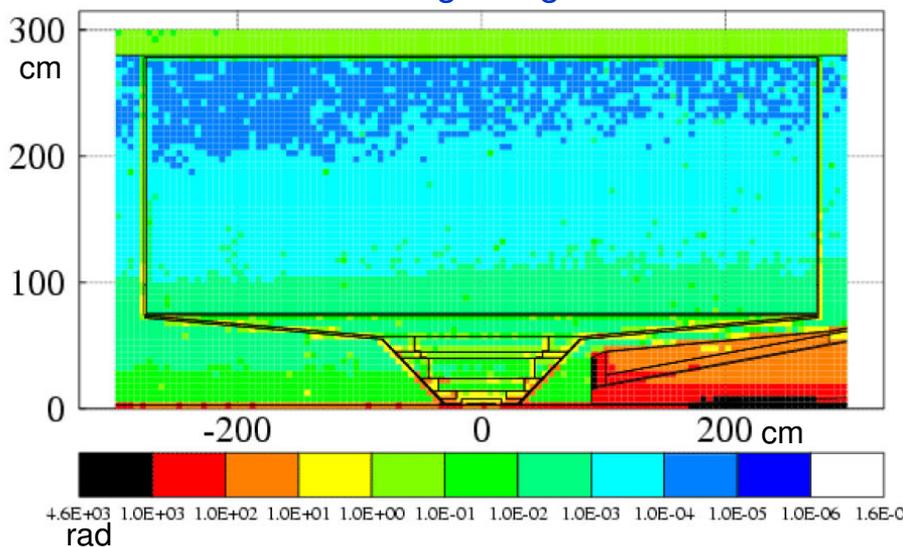
- grazing: full batch ( $4.1 \times 10^{13}$  p) missing the TDI beam stopper, worst case but very unlikely
- sweep: prefire of kicker modules,  $\approx 20$  bunches escape TDI, expected several times/year (?)  $\rightarrow$  main contribution

### Results:

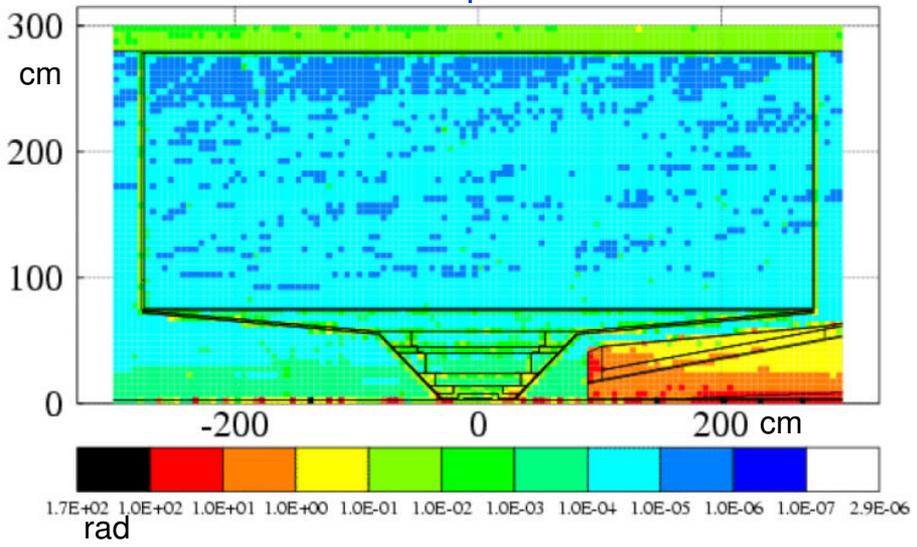
- Accumulated dose during 10 years due to "expected" misinjections is (for Si Pixel Detector and electronics) about 1 krad (1% of total dose from primary collisions)
- Energy deposition maps per accident in Alice detector (vertical section):

Here, for Si, inner tracker: 100 rad  $\sim 10^9$ - $10^{10}$  MIP/cm<sup>2</sup>

"grazing"

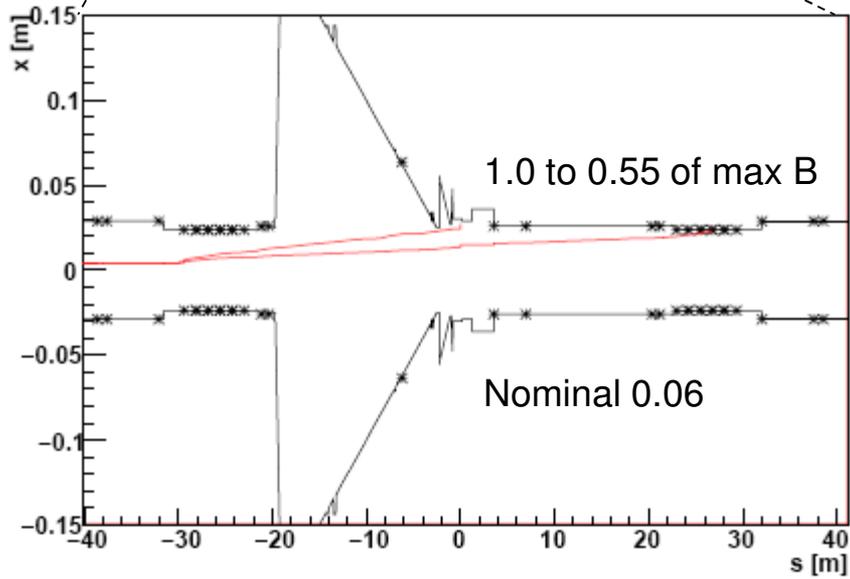
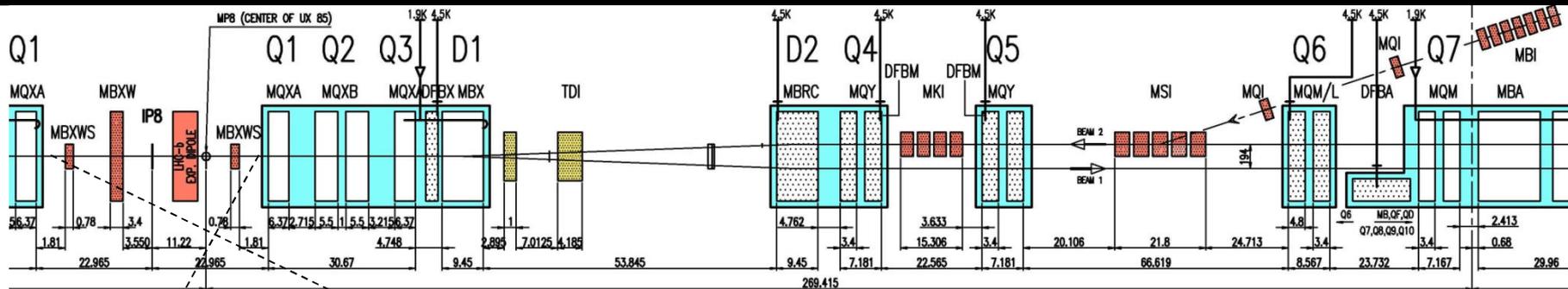


"sweep"





# Example 4: Wrong Compensator Setting at Injection ( here beam2 IP8 )

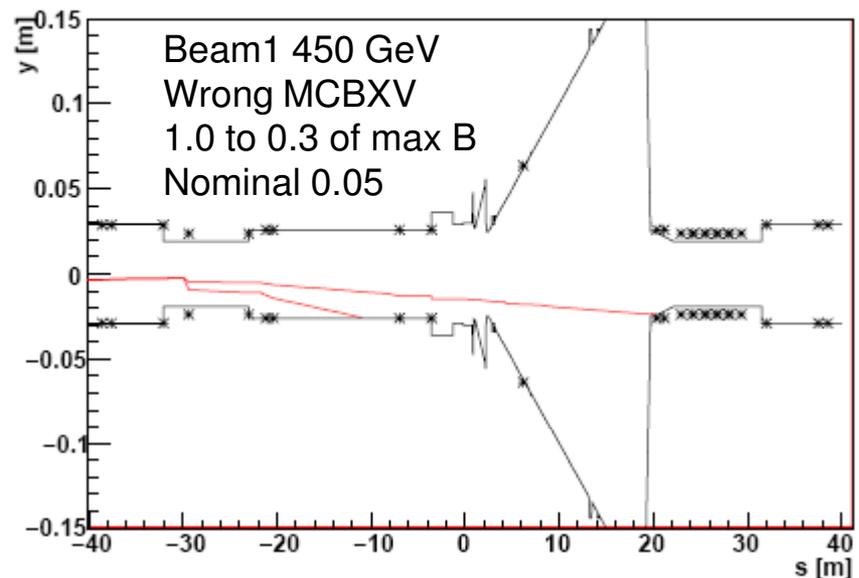
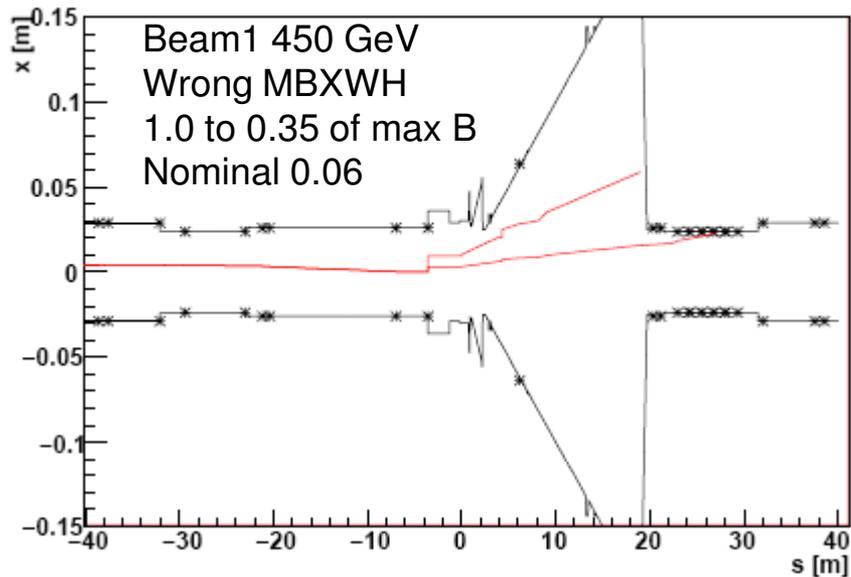


- ❑ Beam2, 450 GeV
- ❑ Wrong setting of MBXWH (horizontal compensator)
- ❑ Beam can hit LHCb detector

LHC Project Report 1174 "LHCb Injected Beam Accidents" R.B. Appleby  
 LHC Project Report 1175 "ALICE Injected Beam Accidents" R.B. Appleby

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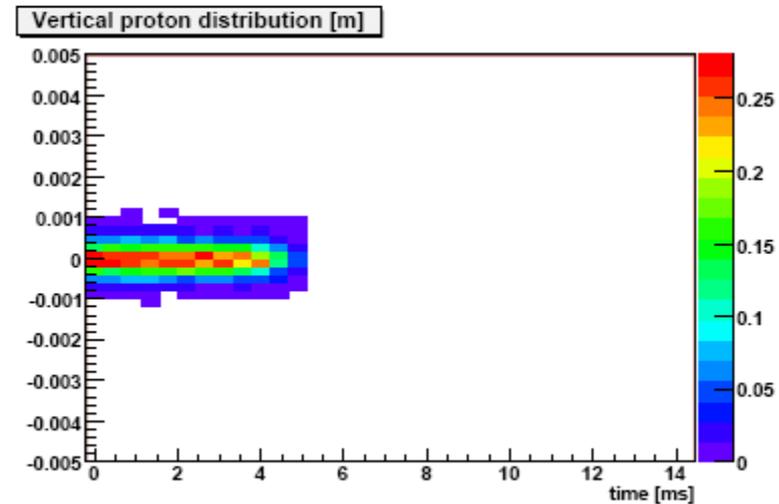
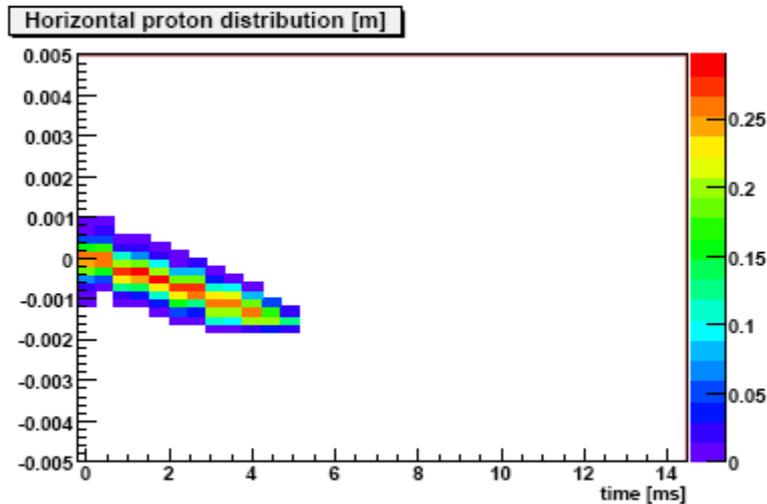
# Example 5: wrong compensator or corrector settings at injection ( here beam1 IP8 )



- ❑ Injected beam does not need to come from nearby injection line!
- ❑ Here beam 1 in LHCb (after almost one turn)
- ❑ Valid for all experiments at LHC

LHC Project Report 1174 "LHCb Injected Beam Accidents" R.B. Appleby  
LHC Project Report 1175 "ALICE Injected Beam Accidents" R.B. Appleby

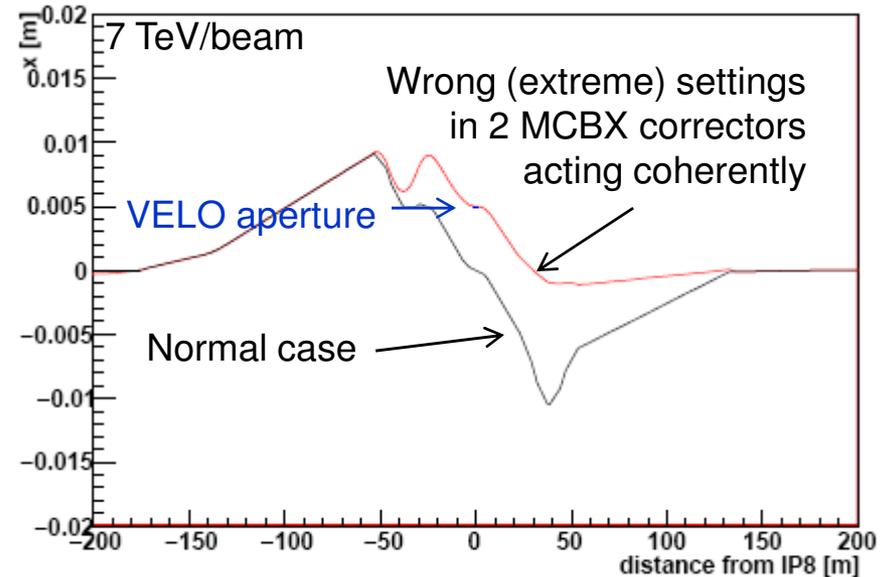
- ❑ Separation magnet D1 going down at 450 GeV
- ❑ Beam mostly caught at primary collimators
- ❑ Here, LHCb VELO would have an aperture of 5 mm radius around the beams



LHC Project Report 1176 "LHC circulating beam accidents for near-beam detectors" R.B. Appleby

## Take again IP8 / LHCb

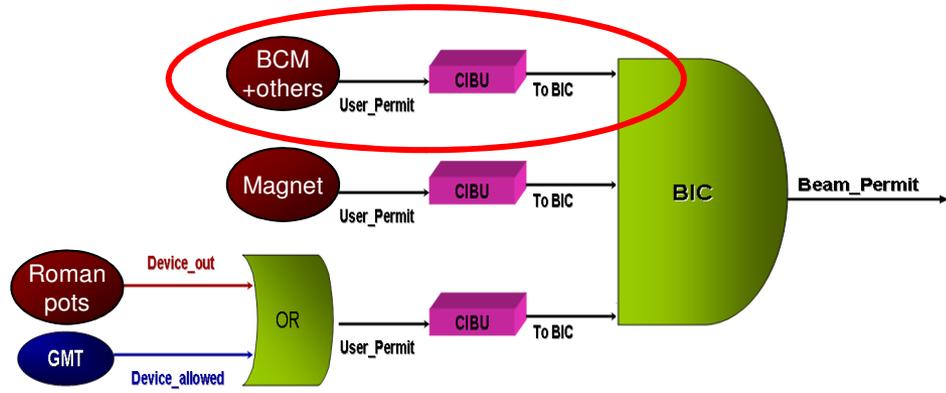
- ❑ Beams separated in Y (vertical) during filling, ramping, etc.
  - Typ. ~ 1 mm between beams at 7 TeV before colliding
  - Max. accessible separation at 7 TeV is a few mm
- ❑ Bump can be local, transparent to rest of machine!
  - Example here at 7 TeV with two magnets
- ❑ The lower the energy, the “easier” to make such a bump
  - At 450 GeV => accessible separation range amplified by factor 15.5, i.e. up to few mm x15.5 !!





## Beam\_permit:

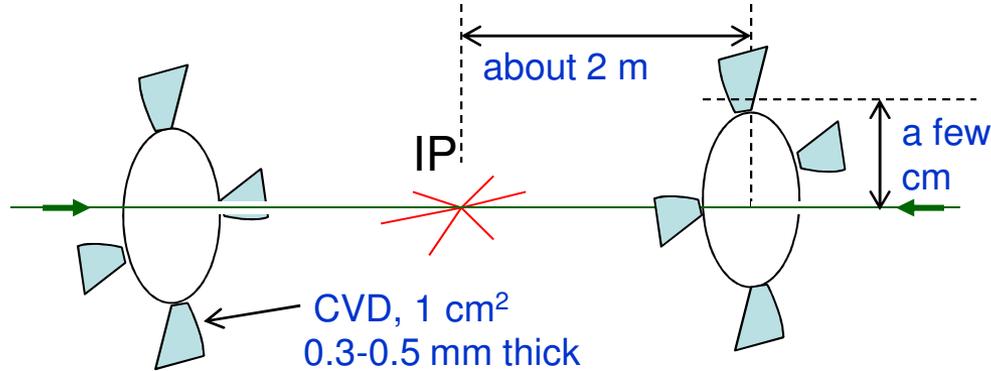
- ❑ In each experiment, several systems (typically 3 or 4) in “and” mode must be alive and deliver a User\_permit
- ❑ If one system remove the User\_permit, it triggers a beam dump
- ❑ Both beams are dumped
- ❑ Recovery procedure after post-mortem data analysis



(emergency buttons are also implemented in some experiments...)

## Injection\_permit:

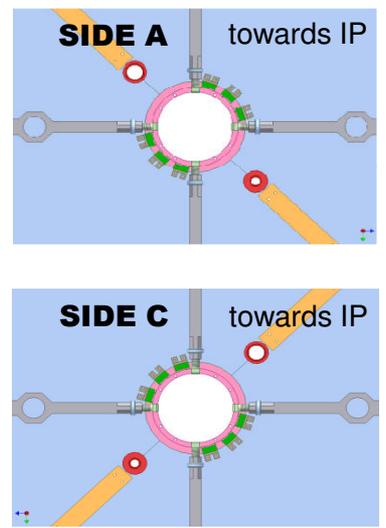
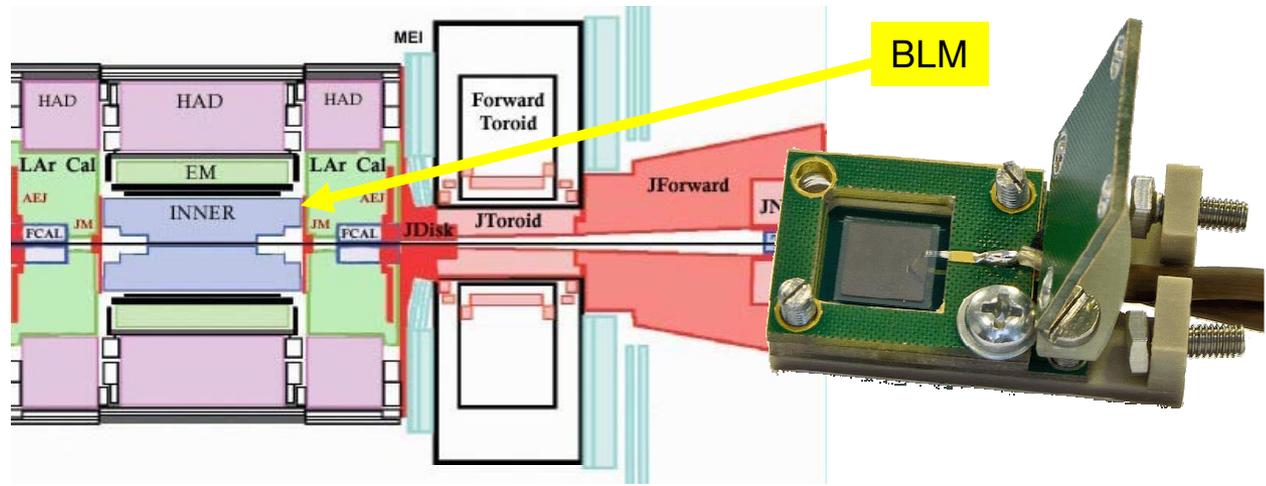
- ❑ Separate interlock based on same transmission hardware (signals to SPS extraction)
- ❑ Allows inhibiting injection into LHC, e.g. when
  - Detector not ready for injection
  - Bad injection detected during a fill, requires stopping injection without dumping the stored beam



- One set of diamond sensors on each side of IP:
  - Stand-alone system using a few polycrystalline CVD diamond pads
  - UPS powered, with few minutes autonomy
  - Post-Mortem analysis capability
  - FPGA-based dump logic:
    - input: measured rates
    - output: UserPermit signal
  - Unmaskable input to local BIC
  - On trigger, dump both beams
  - Expected ready from "day 1"
  - Must have high availability, reliability, efficiency

1 MIP ~ 1 fC

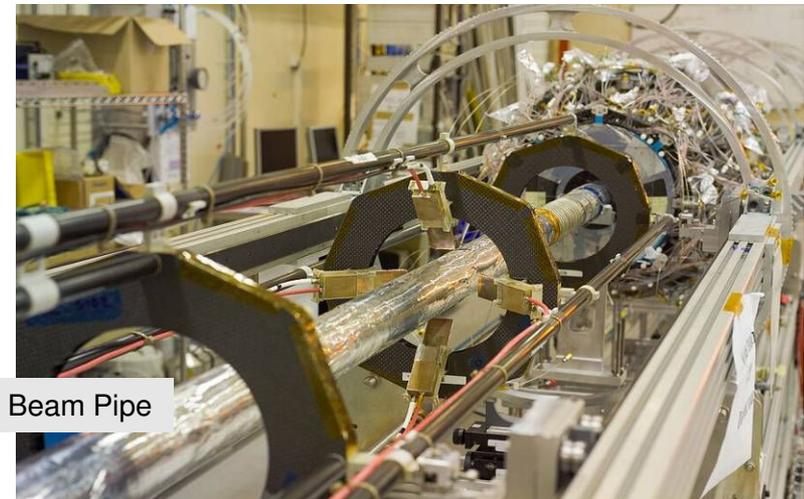
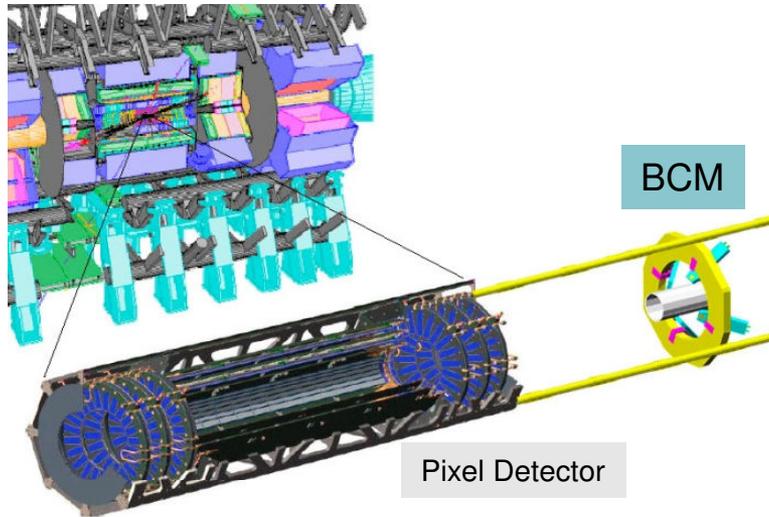
- BCM (beam conditions monitor) must protect detectors against circulating beam failures



- Beam Loss Monitors (BLMXD.01L1/R1.CH0N\_ATLAS)
  - 2 x 6 pCVD diamond detectors (8 x 8 mm<sup>2</sup>)
  - z = ± 345 cm and r = 65 mm
  - 40 μs integration time, pA to mA
  - Readout chain of LHC BLM system with modified BLMTTC FPGA firmware
    - Abort signal at front panel
    - Receive PM signal
- Beam abort condition
  - 2 in a group of 3 detectors above threshold

At nominal 1e34 cm<sup>-2</sup> s<sup>-1</sup>

Noise	Collisions	Thres.	Damage
~10 pA	~15 nA	50 nA (?)	> 1 uA??



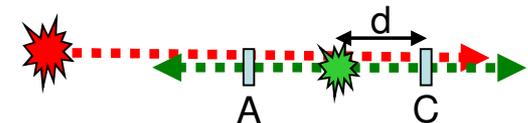
See M. Mikuz et al.,  
NIMA 579 (2007) 788-794

## □ Beam Conditions Monitors (BCM)

- 2 x 4 pCVD diamond detectors (8 x 8 mm<sup>2</sup>)
- z = ± 184 cm and r = 55 mm
- Fast readout time
- Single MIP sensitivity with sub-ns time resolution → Time of flight measurement
- distinguish collisions – background ( $\Delta T(A/C) = 2d/c$ )

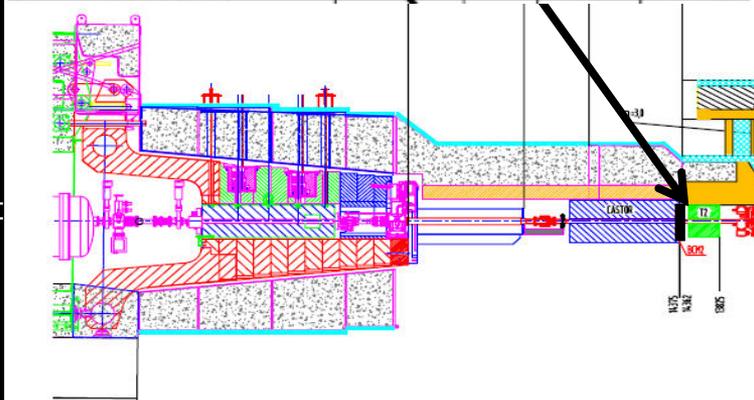
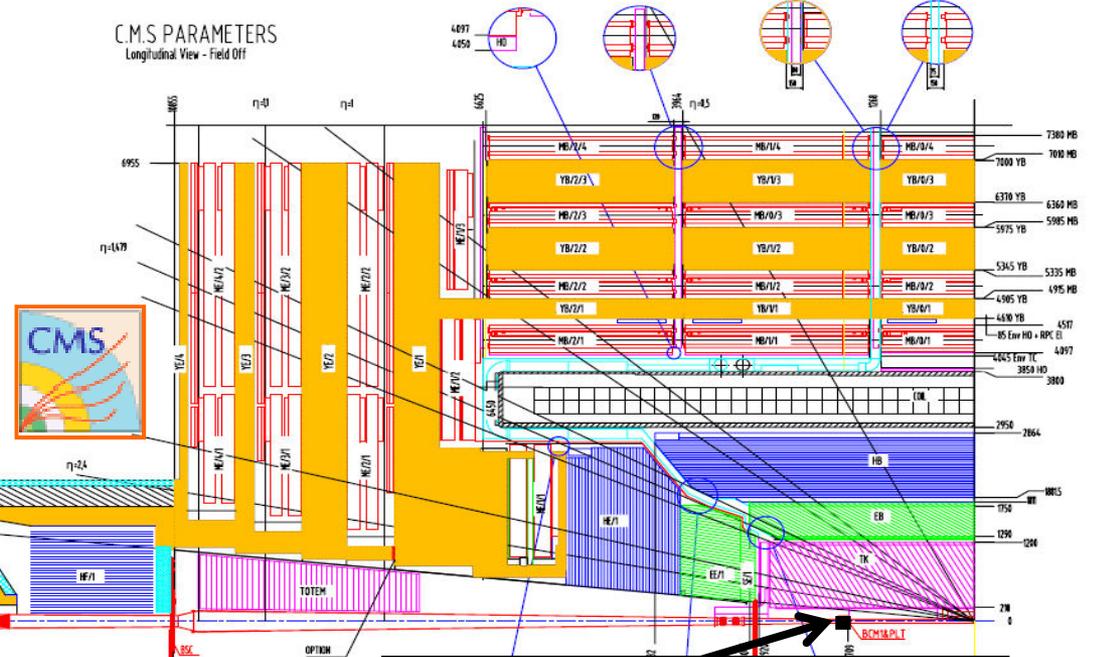
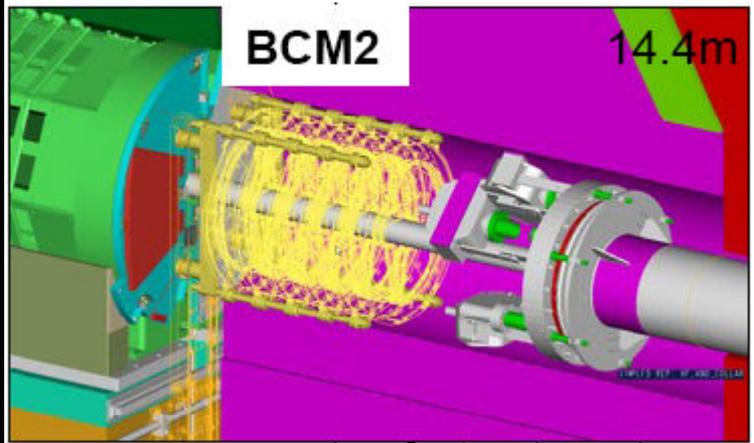
## □ Beam abort condition (not used at start-up)

- 3 sensors above high threshold ( 5 MIPS) AND
- 4 sensors above low threshold (0.5 MIPS)



$d/c = 184 \text{ cm}/c = 12.2 \text{ ns} = \sim 25 \text{ ns} / 2$   
Monitor beam halo by out of time signals vs collisions

see L. Fernandez-Hernando et al.,  
NIMA 552 (2005) 183-188



**BCM2**

- Leakage current monitor
- Polycrystalline Diamond
- Location:  $z = \pm 14.4\text{m}$ ,  $r = 29\text{cm}$ ,  $4.5\text{cm}$
- 8 stations in  $\phi$ , 24 sensors total

**BCM1L**

- Leakage current monitor
- Polycrystalline Diamond
- Usage: Experiment protection

**BCM1F**

- Bunch by bunch monitor
- Single crystal Diamond
- Usage: Pixel protection

- ❑ Initially only 8 diamonds (4 per end) in inner ring on BCM2 will be “active” in asserting BEAM\_PERMIT
- ❑ BCM1L hardware will be connected to the ABORT from the beginning, however thresholds will NOT be set until after a suitable commissioning period with beam
- ❑ BCM1L detectors and inner ring of BCM2 are at ca. 4.5cm radius, approximately the same as innermost layer of pixel detector
- ❑ Initial threshold for BCM2: RS1 ~ 10 uA (40 us)
 

		At nominal $1e34 \text{ cm}^{-2} \text{ s}^{-1}$		
	Noise	Collisions	Thres.	Damage
	<10 pA	~15 nA	10 uA	> 18 uA
- ❑ Thresholds are per diamond. No coincidence required.
  - Has been running stably for > 6 months, w/o spurious triggers



# ALICE (1)



Paris, France

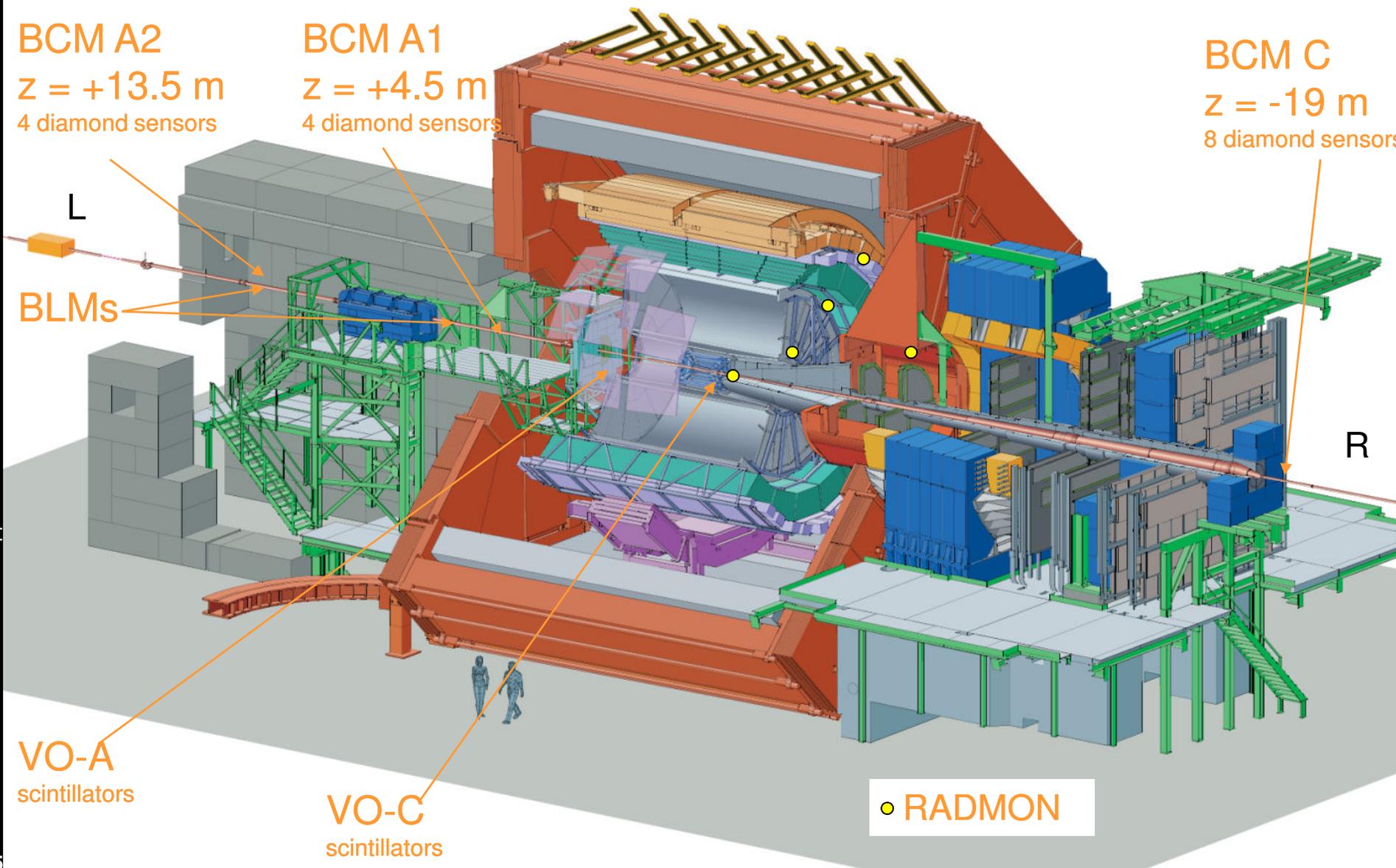


Topical Workshop on Electronics for Particle Physics  
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**BCM A2**  
z = +13.5 m  
4 diamond sensors

**BCM A1**  
z = +4.5 m  
4 diamond sensors

**BCM C**  
z = -19 m  
8 diamond sensors



L  
BLMs

R

**VO-A**  
scintillators

**VO-C**  
scintillators

● **RADMON**

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- ❑ The UserPermit is based on BCM-CFC-TELL1 chain as in LHCb.
  - Fast abort on RS2 (2x40μs CFC integration frames) coincidences:
    - Dump beam if 3 of 4 adjacent diamond sensors show current >  $thr_{RS2}$
  - Slow abort on ΣRS32 (32x40μs):
    - Sorting out the two highest and the lowest of 8 sensors, dump beam if  $\Sigma RS32 > thr_{\Sigma RS32}$
- ❑ Current estimate for dump thresholds (to be x-checked ...):
  - $thr_{RS2} \sim 5000 \text{ nA}$  ,  $thr_{\Sigma RS32} \sim 250 \text{ nA}$

Noise	Collisions	Thres.	Damage
<100 pA	~100 pA	~ 5 uA	~ mA

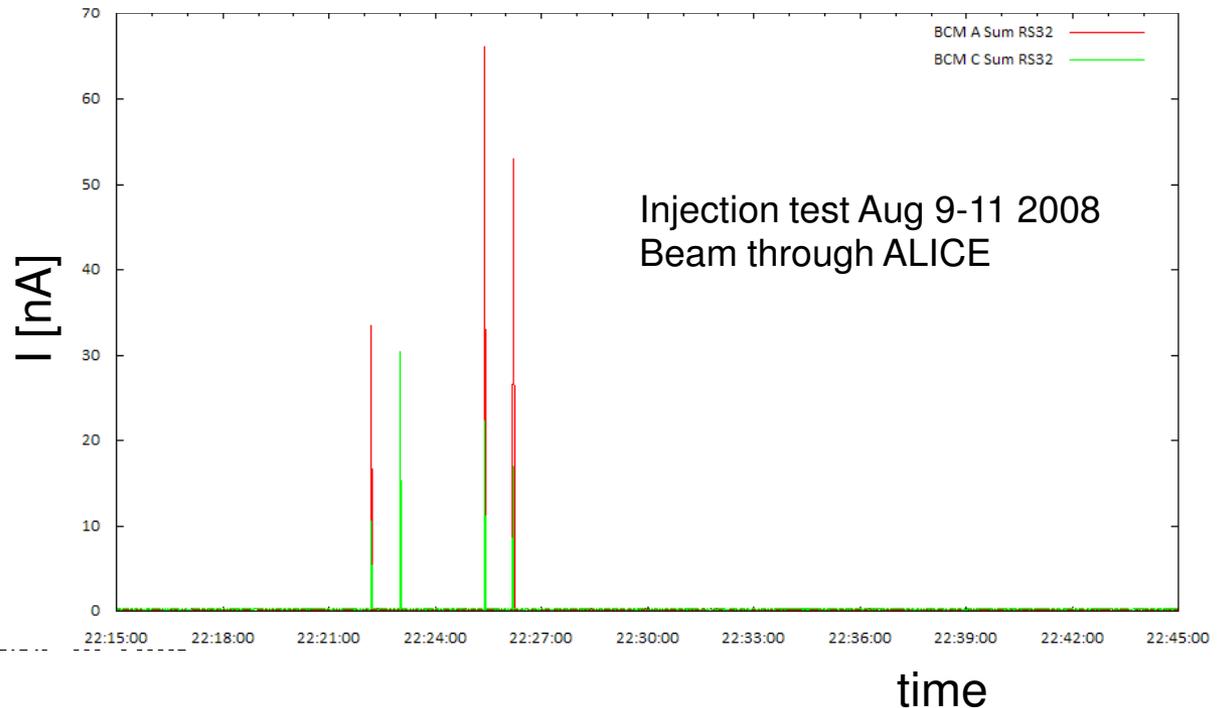
BCM currents from FLUKA simulation of injection failures by B. Pastirčák (ALICE Int. Note 2001-03), updated in Nov 07

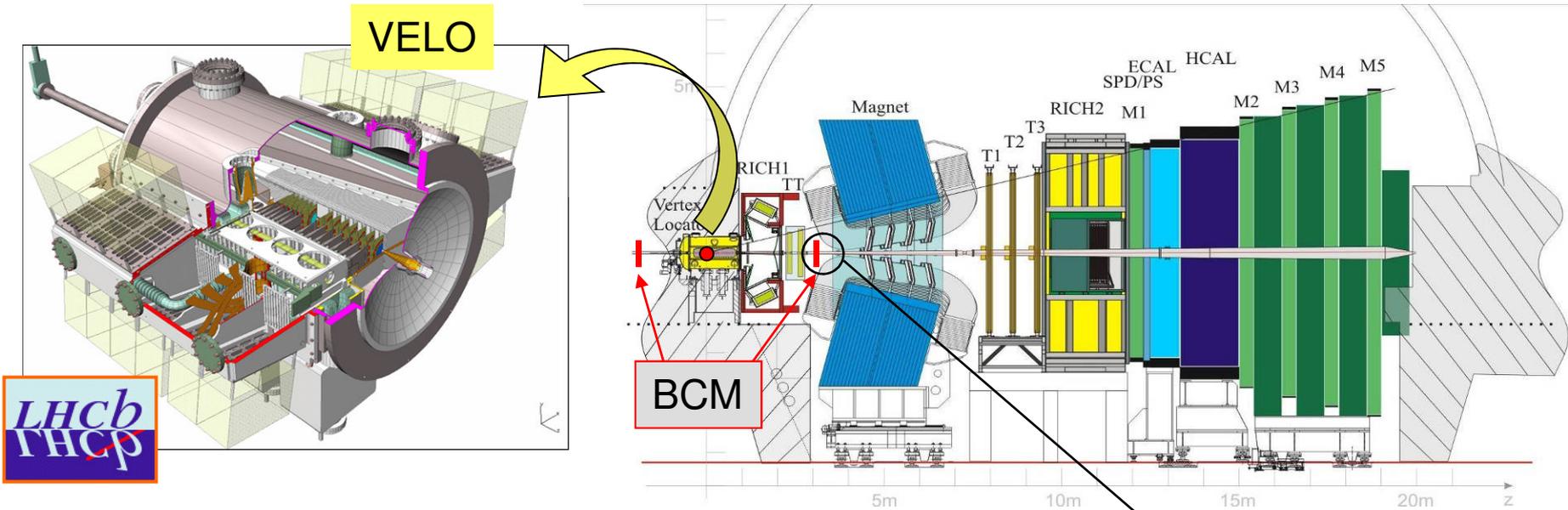
(pilot bunch  $5 \times 10^9 \text{ p}$ )

	RS2 [nA]	RS32 [nA]
BCM A	≈500-750	≈30-50
BCM C	≈100	≈6

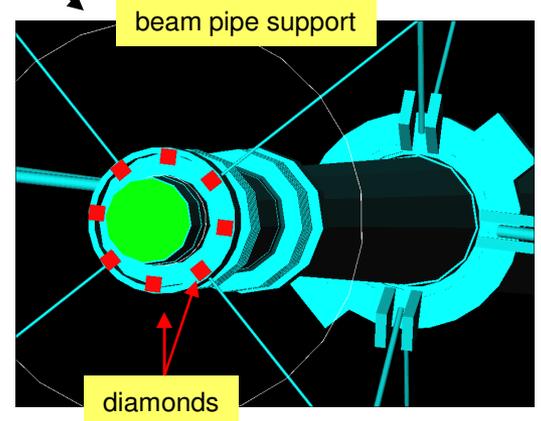
TDI grazing (pilot bunch  $5 \times 10^9 \text{ p}$ )

	RS2 [nA]	RS32 [nA]
BCM A	≈900-2700	≈55-170
BCM C	≈325	≈20

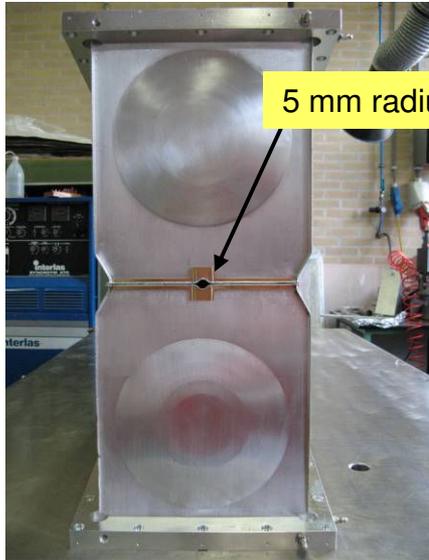




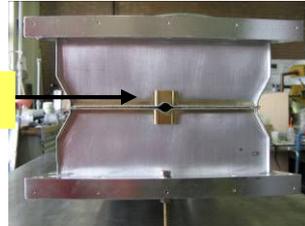
- ❑ Each BCM station composed of 4 or 8 CVD diamonds
- ❑ Mounted on the beam pipe, about 6 cm away from beam axis
- ❑ Asymmetric layout of BCM around IP (space availability)
- ❑ Diamonds readout: integrated rates in 40 us (later upgrade to 25 ns ?)
- ❑ Use stand-alone readout board for algorithm on dump trigger decision
- ❑ Simulations ongoing (relate VELO rates to BCM rates in failure scenarios)



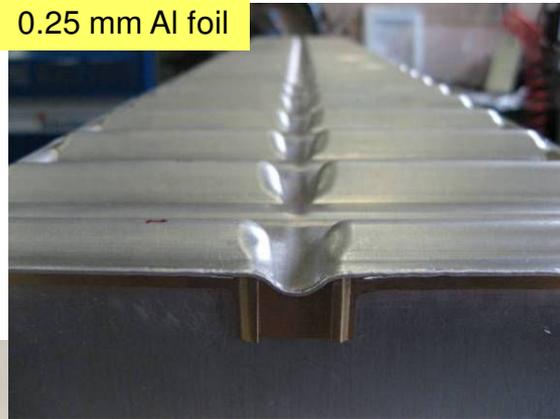
Noise	Collisions	Thres.	Damage
<10 pA	~1 nA	few uA	> ?? uA



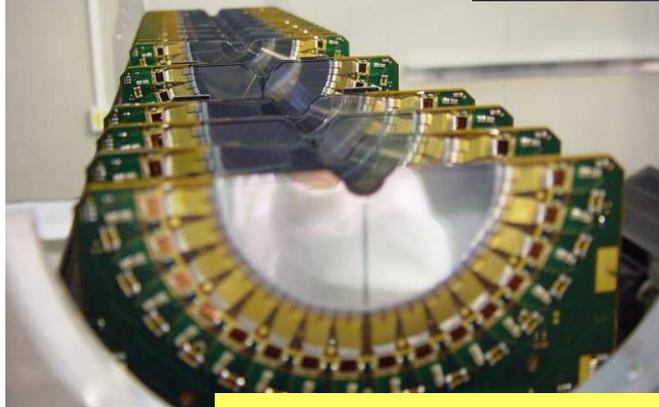
5 mm radius



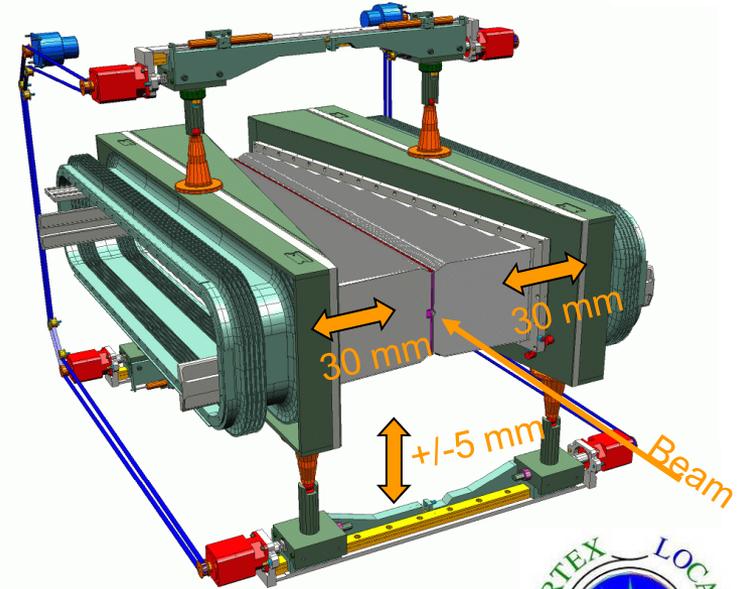
0.25 mm Al foil



21 r-phi Si modules per side



0.25 um CMOS ASICs (Beetle)



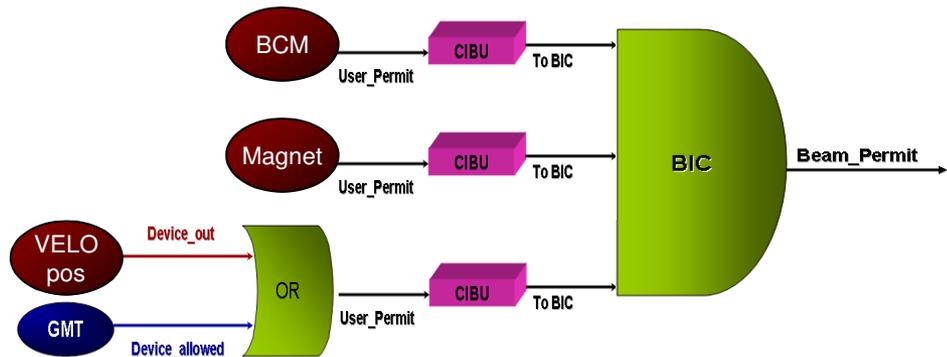
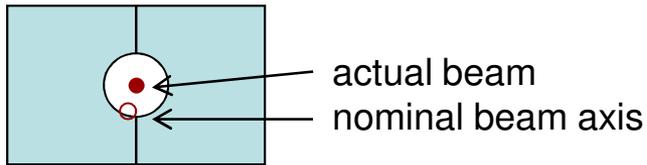
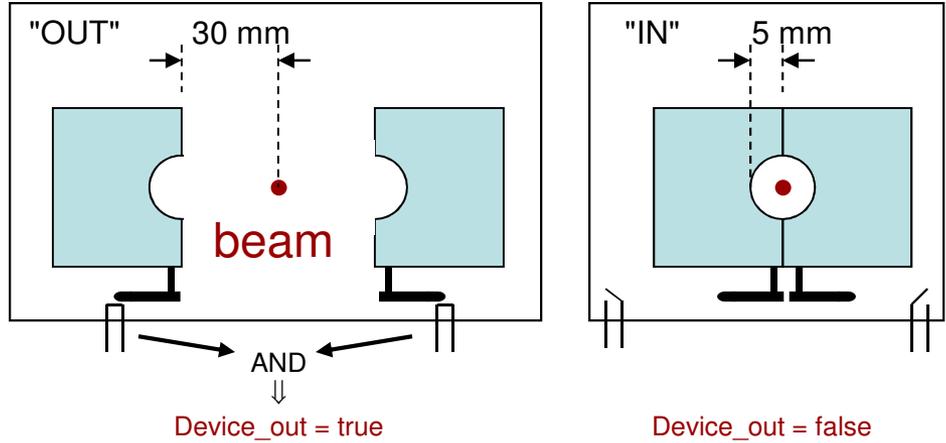
- ❑ Injection: no material at  $r < 27$  mm  $\Rightarrow$  Velo open (OUT)
- ❑ During stable beam  $\Rightarrow$  Velo closed (IN)
- ❑ Final position adjustable in y and in x to center beam in the hole (axial geometry for RZ trigger !)
- ❑ It must be possible to adjust "beyond" nominal beam axis (beam position not guaranteed...)
- ❑ Microswitches to detect Velo is OUT (both halves)
- ❑ Microswitches and hard stops to prevent crashes



# LHCb VELO Protection System



- Microswitches in X on each half to check that VELO is in garage position (OUT)
- Read out by PLC which generates **Device\_out** signal
- LHC flag **Device\_allowed** transmitted via reliable network to the Expts. If False, movable devices must be in OUT position
- If both LHC flag **Device\_allowed** and VELO flag **Device\_out** are false, then LHCb **UserPermit** is false => dump the beam, prevent injection
- VELO motion is "slow", of order 0.1 mm/s
- Can move over nominal beam axis and/or beam can move to the detector!
  - => fast protection needed !
  - => BCM must detect increase in rate (over normal minimum bias events) due to a possible beam-VELO foil scraping, must work for both beams



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What are the most exposed / most sensitive detectors ?

What are their damage thresholds ?

Why do we care ?

- ❑ Detectors are designed, built and installed: but operation procedures can be changed
  - HV and LV on/off at injection or with “non-physics” circulating beam ?
- ❑ Feedback to the machine
  - Definition of intensity limit at injection
    - Currently H/W  $10^{11}$  protons and S/W  $10^{10}$
- ❑ Improvements on future detectors (at even higher beam intensities...)



# Risks for LHC Vertex Detectors



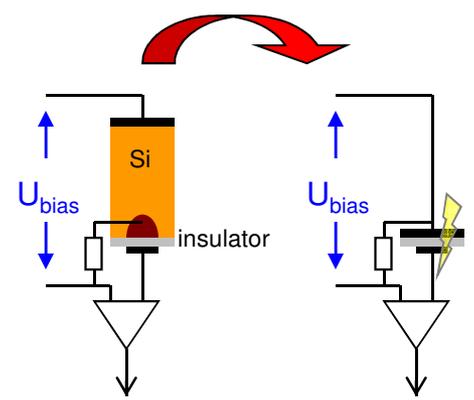
## Problems with beam losses for the silicon:

- ❑ Heat deposit: not a problem ? (for the likely failures)
  - Thermomechanicql effects ? Seeds for crqcks ?
- ❑ Extra radiation damage, eating up the "budget"
  - not so critical: LHC Si detectors designed to sustain "huge" doses (few  $10^{14}$   $n_{eq}/cm^2 \sim 10$  Mrad) ;
  - but watch out anyway!
- ❑ Sudden high rate can induce large voltage in the Si detector
  - becomes essentially conductor => bias voltage boundary moves to another place... zap or no zap ?
    - e.g.  $SiO_2$  breaks at  $\sim 1V/nm$
  - direct hit to FE chip can be even worse (lose full chip, i.e. many channels... see CDF accidents)



For comparison:

- Atlas/CMS pixel ( $r=4.3cm$ ): order of  $0.02$  MIP/cm<sup>2</sup> per pp interaction
- LHCb VELO: order of  $0.5$  MIP/cm<sup>2</sup> per pp interaction
- MIPs through pixel detectors due to pp collisions in IP1/5 in a nominal year  $\sim 10^{17...18}$
- One nominal LHC bunch:  $10^{11}$  p
- Full nominal LHC beam:  $3 \times 10^{14}$  p



## The keep-it-always-on-or-not dilemma:

- ❑ Keep detector always ON for stability ?
  - no charge up effects, no temperature effects, etc.
- ❑ Reduce risk during injection by turning OFF HV ? (or even LV off)?
  - unstable at turn-ON

What do we know about LHC Expt Si detector and resistance to high rates ?



## ATLAS and CMS tests at CERN PS beam:

- ❑ 24 GeV, 1 or few-bunch batch (bunch: 42 ns long,  $\sim 10^{11}$  p, separation 256 ns), with peak bunch density of  $\sim 3 \times 10^{10}$  p/cm<sup>2</sup>.
- ❑ Detectors biased and FE electronics ON
  
- ❑ ATLAS:
  - See A. Andreazza, K. Einsweiler, C. Gemme,, L. Rossi, P. Sicho, NIM A 565 (2006) 50–54, *Effect of accidental beam losses on the ATLAS pixel detector*
- ❑ CMS:
  - See M. Fahrner, G. Dirkes, F. Hartmann, S. Heier, A. Macpherson, Th. Müller, Th. Weiler, NIM A518 (2004) 328–330, *Beam-loss-induced electrical stress test on CMS Silicon Strip Modules*

## Laser tests (not exhaustive):

- ❑ Atlas silicon strip: 1064 nm LASER (1 W)
  - K. Hara, T. Kuwano, G. Moorhead, Y. Ikegami, T. Kohriki, S. Terada, Y. Unno, NIM A 541 (2005) 15–20, *Beam splash effects on ATLAS silicon microstrip detectors evaluated using 1-w Nd:YAG laser*
- ❑ Atlas silicon strip sensors: LASER (2 types)
  - T. Dubbs, M. Harms, H. E-W. Sadrozinski, A. Seiden, M. Wilson, IEEE Trans. Nucl. Sci. NS47 (2000) 1902, *Voltages on Silicon Microstrip Detectors in High Radiation Fields*

- Andreatza et al., NIM A 565 (2006) 50–54
- ⇒ « The results of the PS experiment therefore indicate that the loss of a LHC “pilot beam” of  $5 \times 10^9$  protons should not make any sizeable permanent damage to the performance of the ATLAS pixel detector. This accident will, very likely, require a reloading of the configuration parameters in a large fraction of the pixel detector. »

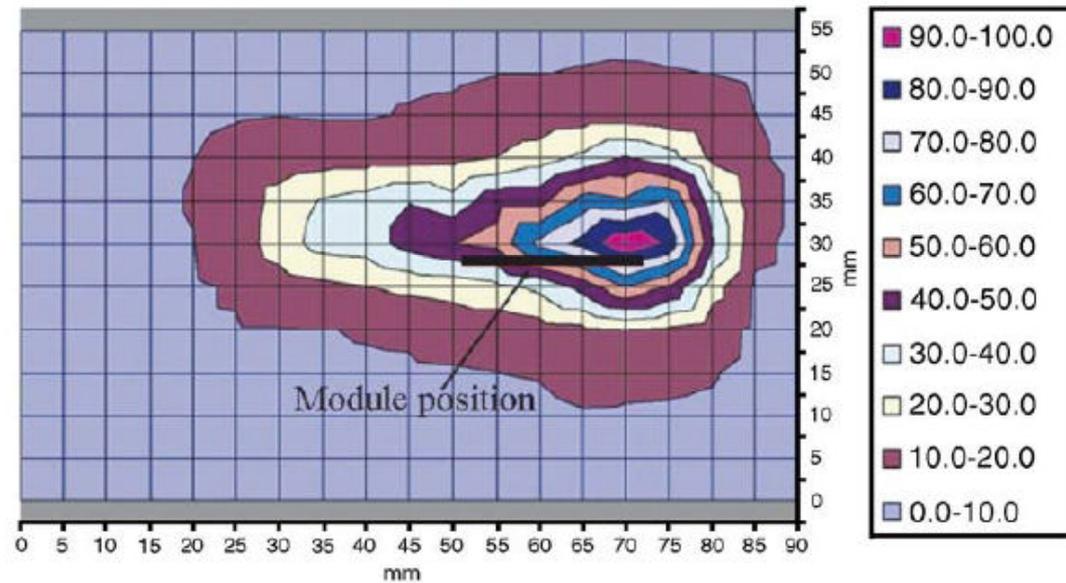


Fig. 3. Beam profile of a  $10^{11}$  proton bunch extracted from the CERN Proton Synchrotron and measured in the vicinity of the ATLAS pixel module, which is also shown. The beam intensity is of  $\approx 3 \times 10^{10}$  p/cm<sup>2</sup> in a central area of  $\approx 5 \times 3$  mm<sup>2</sup>. The average flux over the module is of  $1.5 \times 10^{10}$  p/cm<sup>2</sup>.

- M. Fahrner et al., NIM A518 (2004) 328–330
- ⇒ « There is strong evidence that CMS silicon strip modules will survive a beam loss, because the fast breakdown of bias voltage protects electronics and sensors, especially the dielectric layer and the polysilicon resistors. »

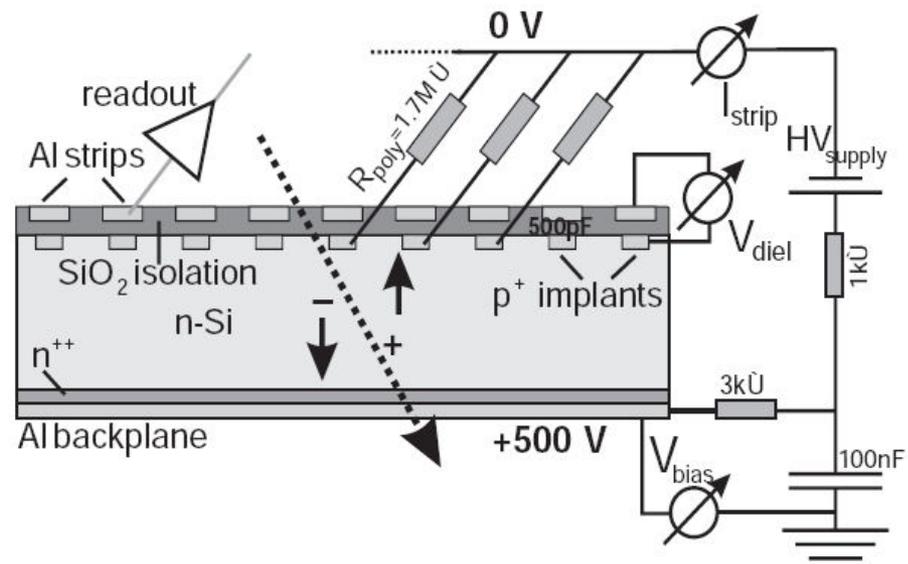


Fig. 1. Sensor schematics with electrical setup.

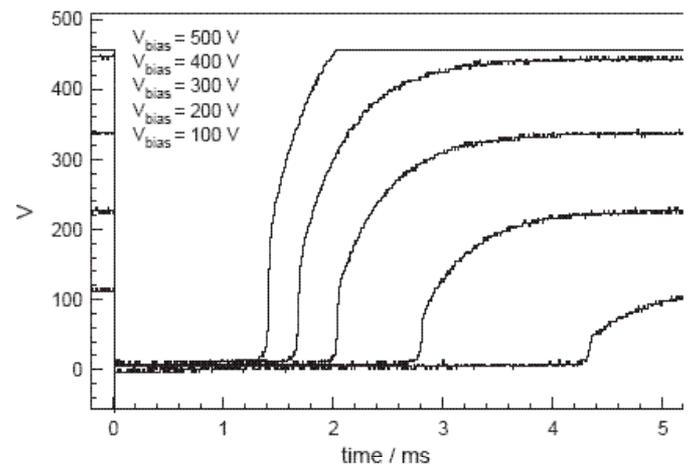


Fig. 2. Time behaviour of bias voltage.

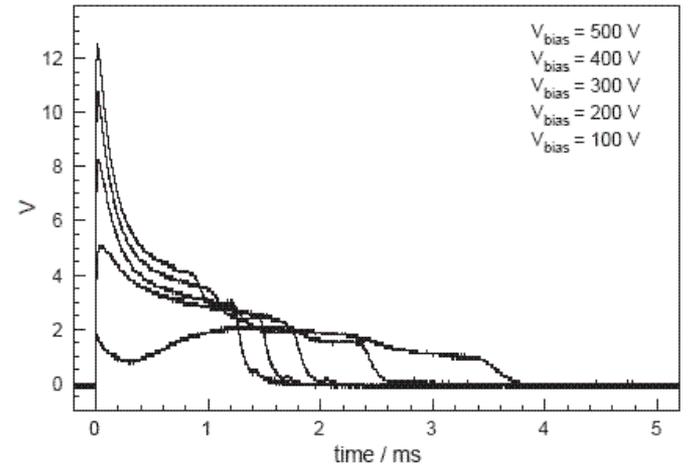


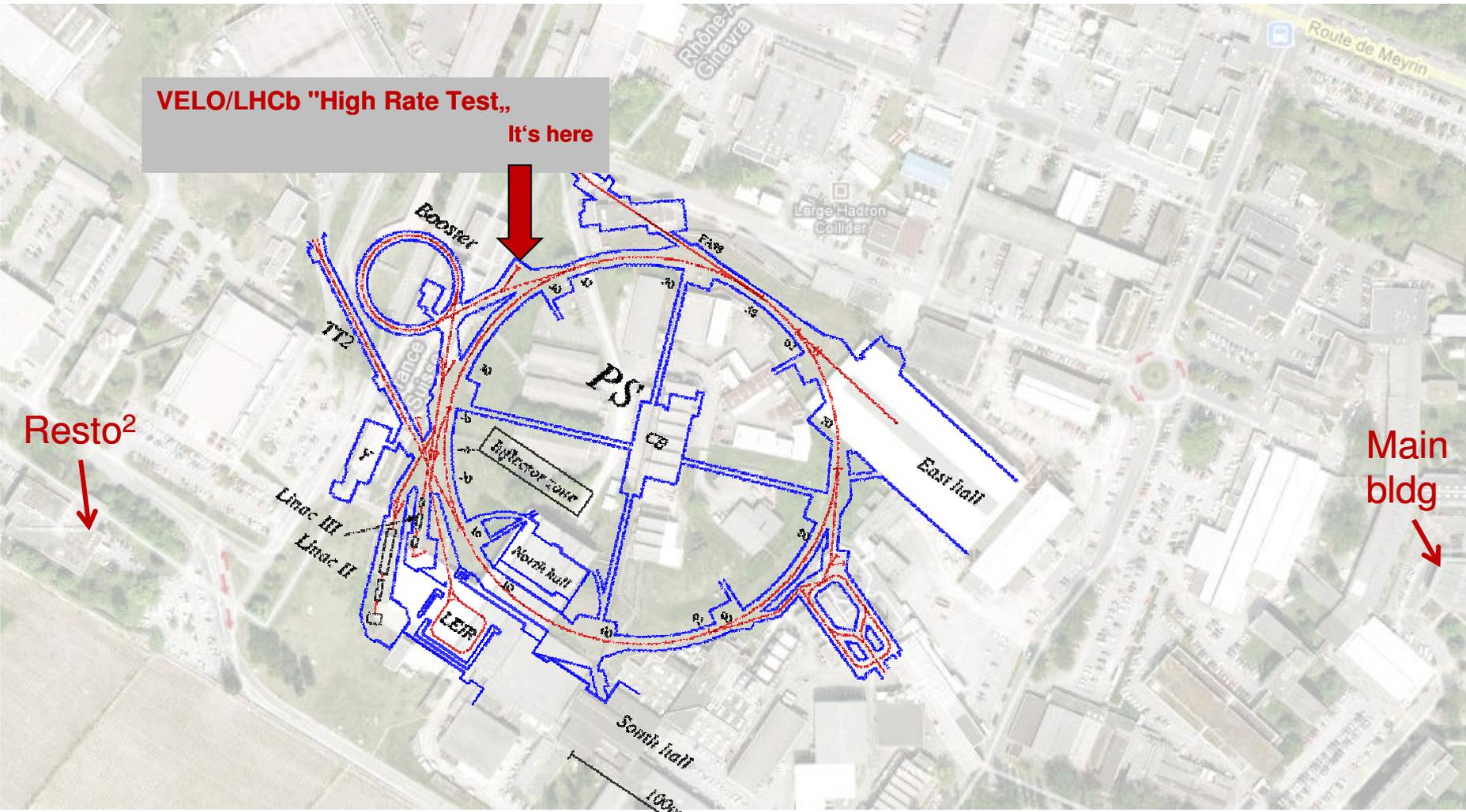
Fig. 3. Time behaviour of voltage over dielectric layer.



# A Recent LHCb VELO High Rate Test



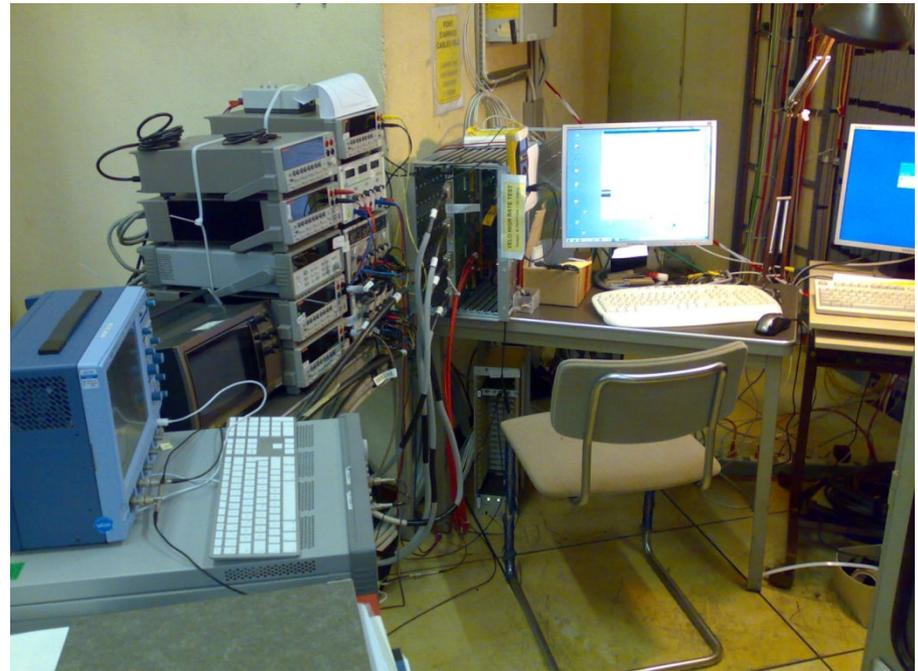
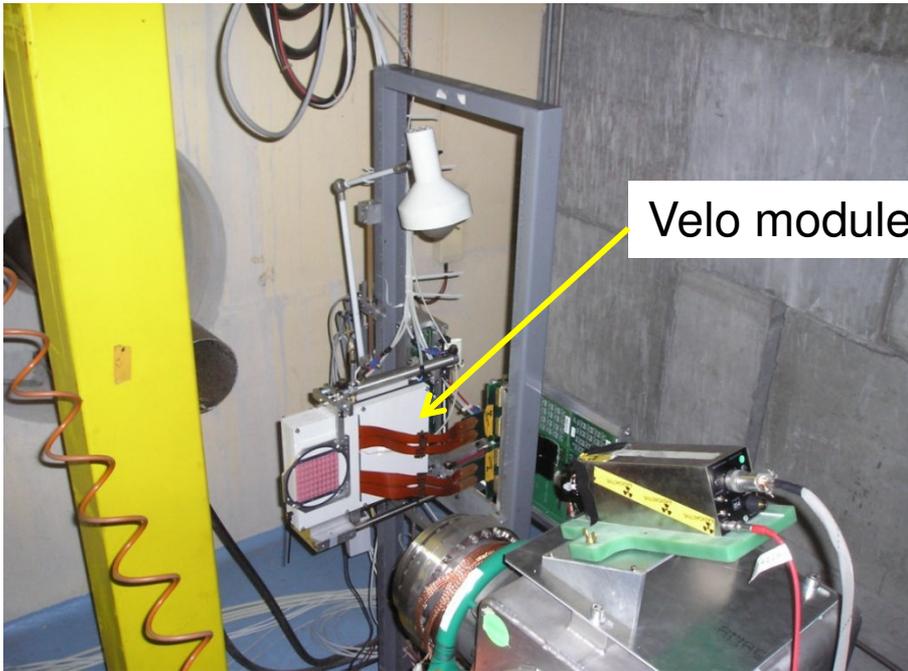
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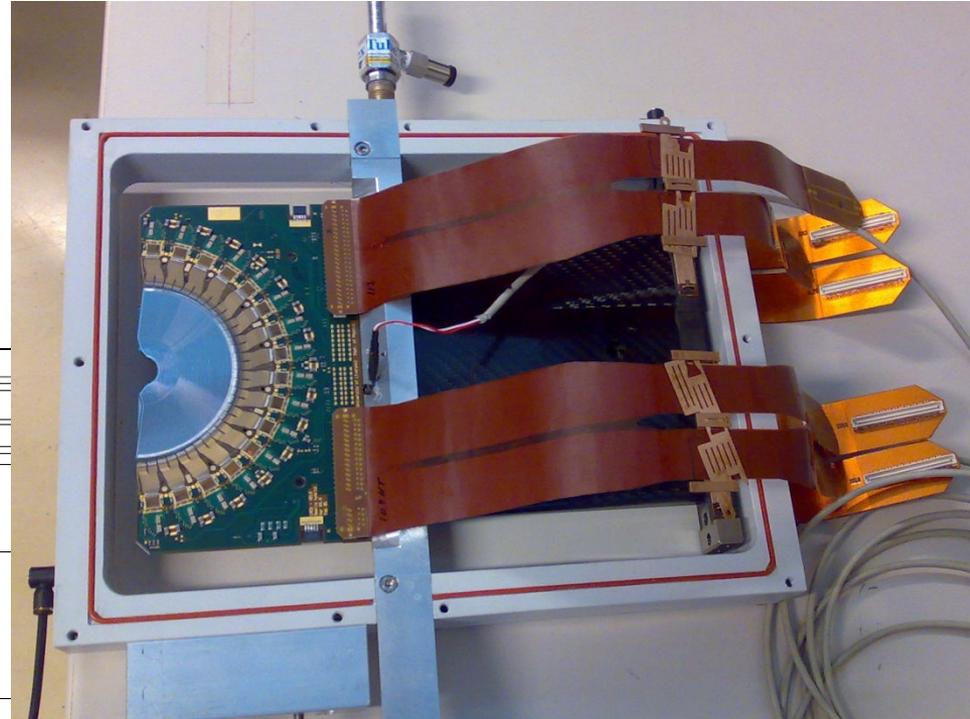
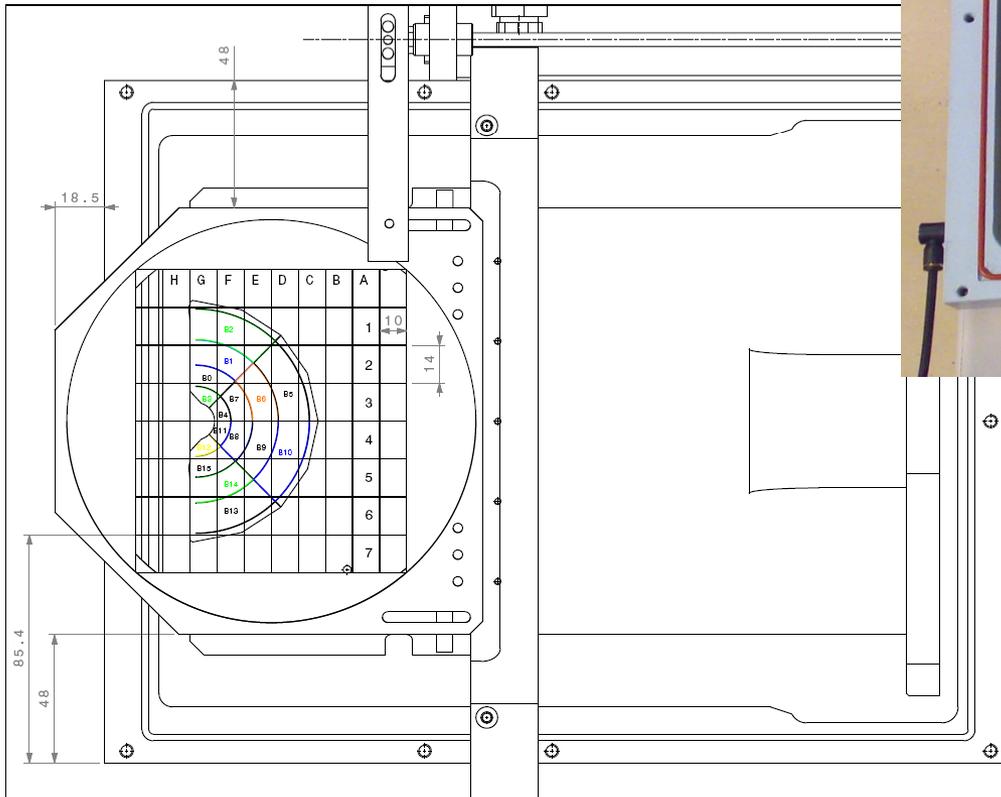
Module mounted close to the PS booster (PSB) beam dump

- ❑ Proton beam of 1.4 GeV kinetic energy
- ❑ Intensity from  $2e9$  to  $9e12$  p/bunch
- ❑ 1 to 4 bunches (4 rings), we use a single bunch (ring 3)
- ❑ Beam spot size rms  $\sim 2-4$  mm , bunch duration rms  $\sim 20-60$  ns



## LHCb/Velo spare from production

- Back-to-back R & Phi sensors
- 2048 AC coupled n-on-n strips / side
- 16 FE chips (IBM 0.25  $\mu\text{m}$ ) per side, all configured but only 8 per side read out

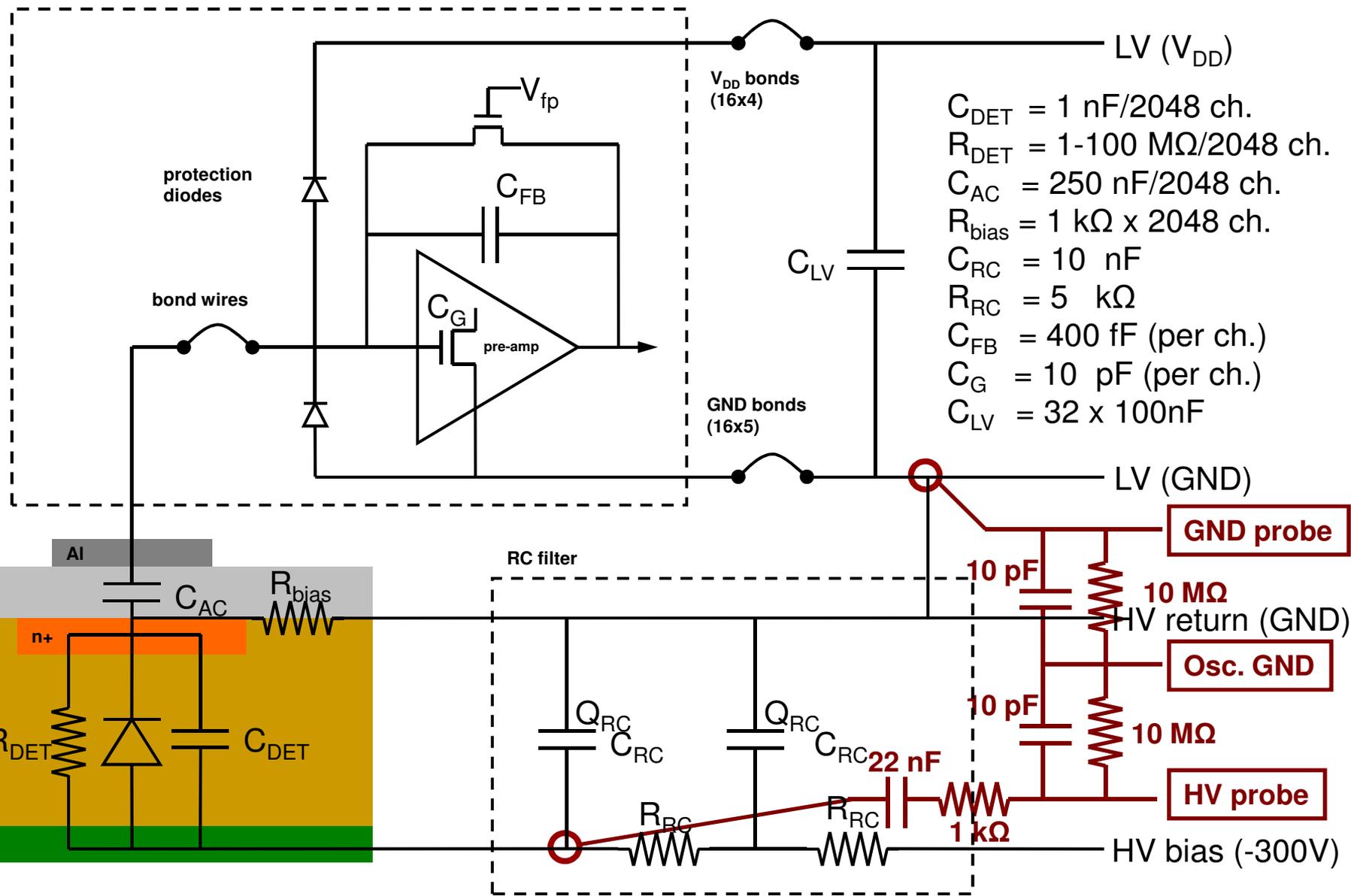
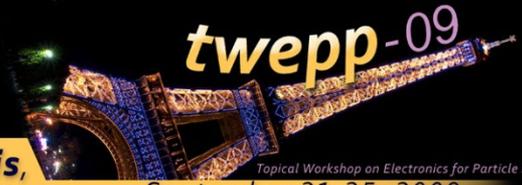


## Mounted in the beam line

- Cooled to  $+1\text{ }^{\circ}\text{C}$  (LV on) with vortex tube (8 bar compressed air)
- Fluorescent screen to view the beam
- Insert/retract from beam line
- Remote control and read-out
- Heavy radiation environment !
  - Backsplash at every beam dump
  - $\sim 1\text{ kGy}$  in a few months



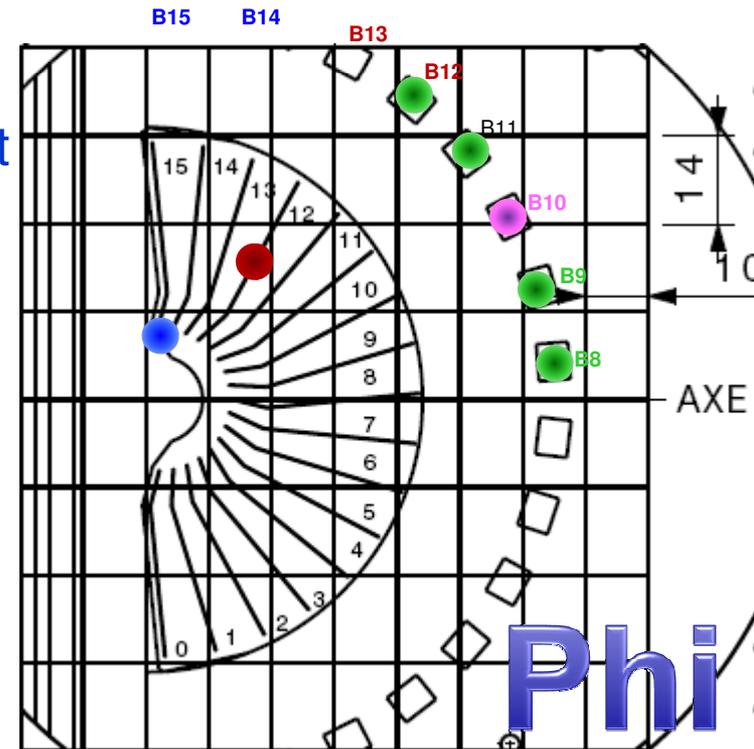
# Electrical model – static case



- $C_{DET} = 1 \text{ nF}/2048 \text{ ch.}$
- $R_{DET} = 1\text{-}100 \text{ M}\Omega/2048 \text{ ch.}$
- $C_{AC} = 250 \text{ nF}/2048 \text{ ch.}$
- $R_{bias} = 1 \text{ k}\Omega \times 2048 \text{ ch.}$
- $C_{RC} = 10 \text{ nF}$
- $R_{RC} = 5 \text{ k}\Omega$
- $C_{FB} = 400 \text{ fF (per ch.)}$
- $C_G = 10 \text{ pF (per ch.)}$
- $C_{LV} = 32 \times 100\text{nF}$

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- ❑ Intensity steps:  $2 \times 10^9$ ,  $2 \times 10^{10}$ ,  $2 \times 10^{11}$ ,  $2 \times 10^{12}$  &  $9 \times 10^{12}$
- ❑ Each step: LV/HV off, LV on/HV off, LV on/HV 150 V & LV on/HV 300V
- ❑ Each beam 'shot' follows the same pattern
  - A set of standard measurements
    - I/V of both sensors
    - Noise & pedestal data
    - Test pulse data at +1.5, 0 and -150 V
  - Insert the module, acquire during the shot
    - 14 consecutive triggers of front-end data
    - Voltage on hybrid GND and sensor bias via oscilloscope
    - Beam spot image via a camera
  - Repeat the same set of measurements
- ❑ Shots on two sensor positions
- ❑ Shots on five front-end chips (here only LV on/off matters)





# Beam images

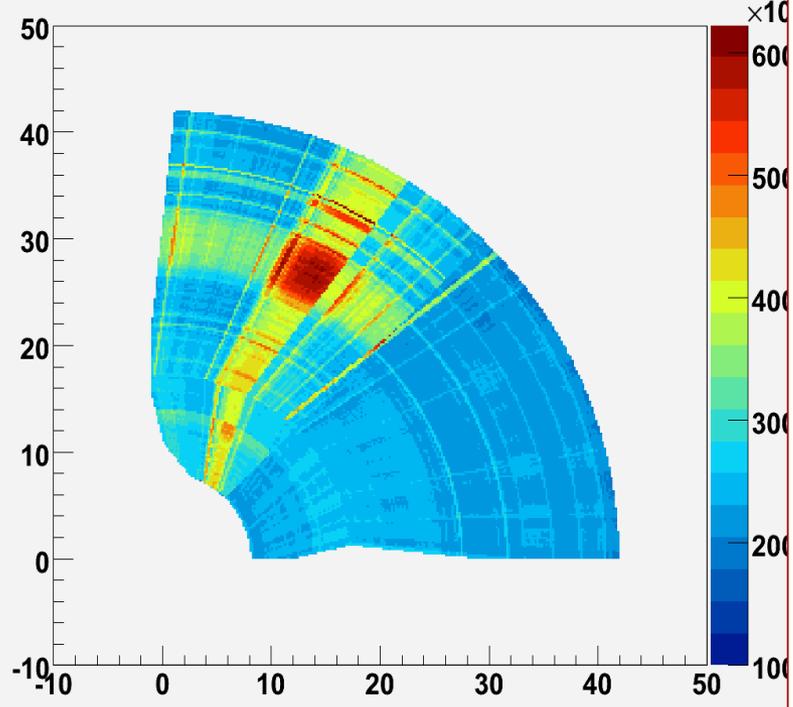


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## Combined R- $\Phi$ sensor front-end data

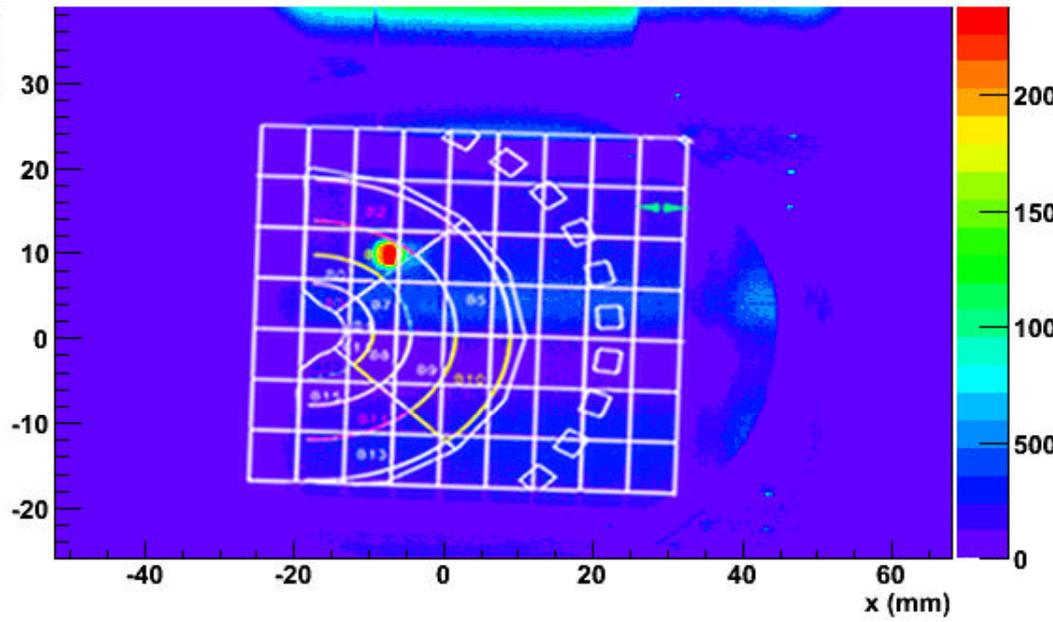
Velo Sensors Strip configuration

hstrip2comb	
Skewness x	nan
Skewness y	nan



8

## Beam line camera on fluorescent screen



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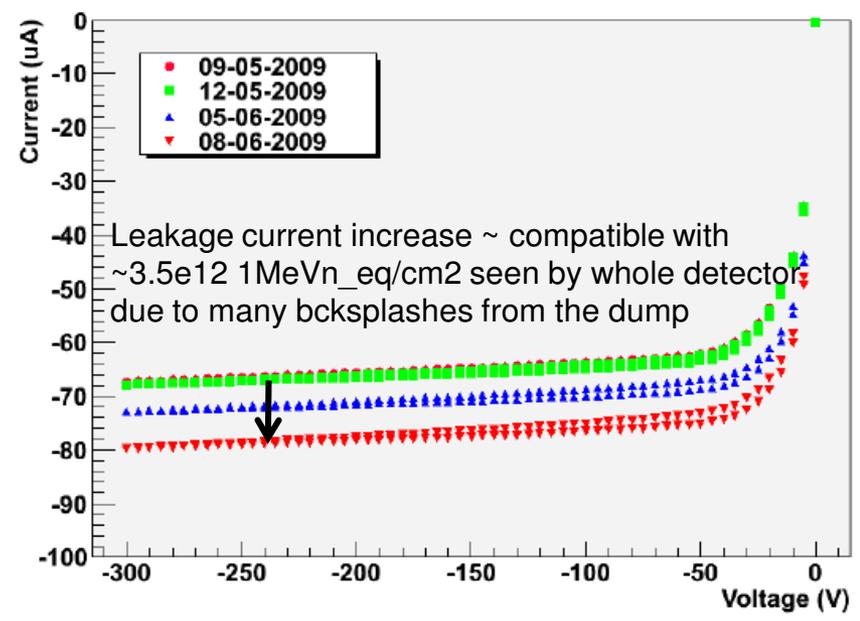
# I/V curves



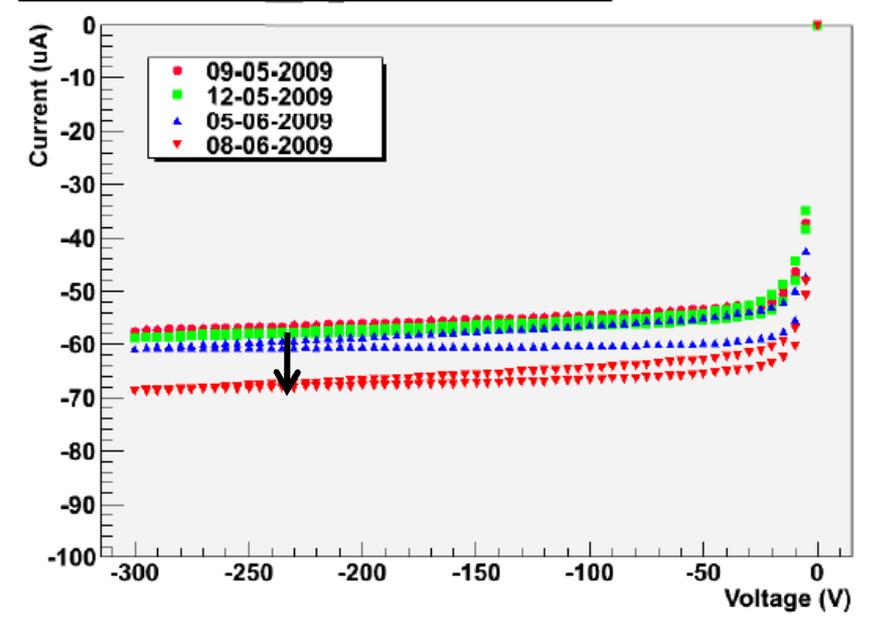
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- I/V curves in-situ between each shot
  - Superimpose temperature corrected I/V curves
  - Small increase probably due to accumulated dose
  - Rough estimate between first and last curve:  $\sim 3.5 \times 10^{12}$  1-MeV- $n_{eq}$  /cm<sup>2</sup> ( $\sim 1$  kGy)
- Work in progress
  - Correlate with radiation monitoring data

R IV Scans normalised to -3 degrees



Phi IV Scans normalised to -3 degrees



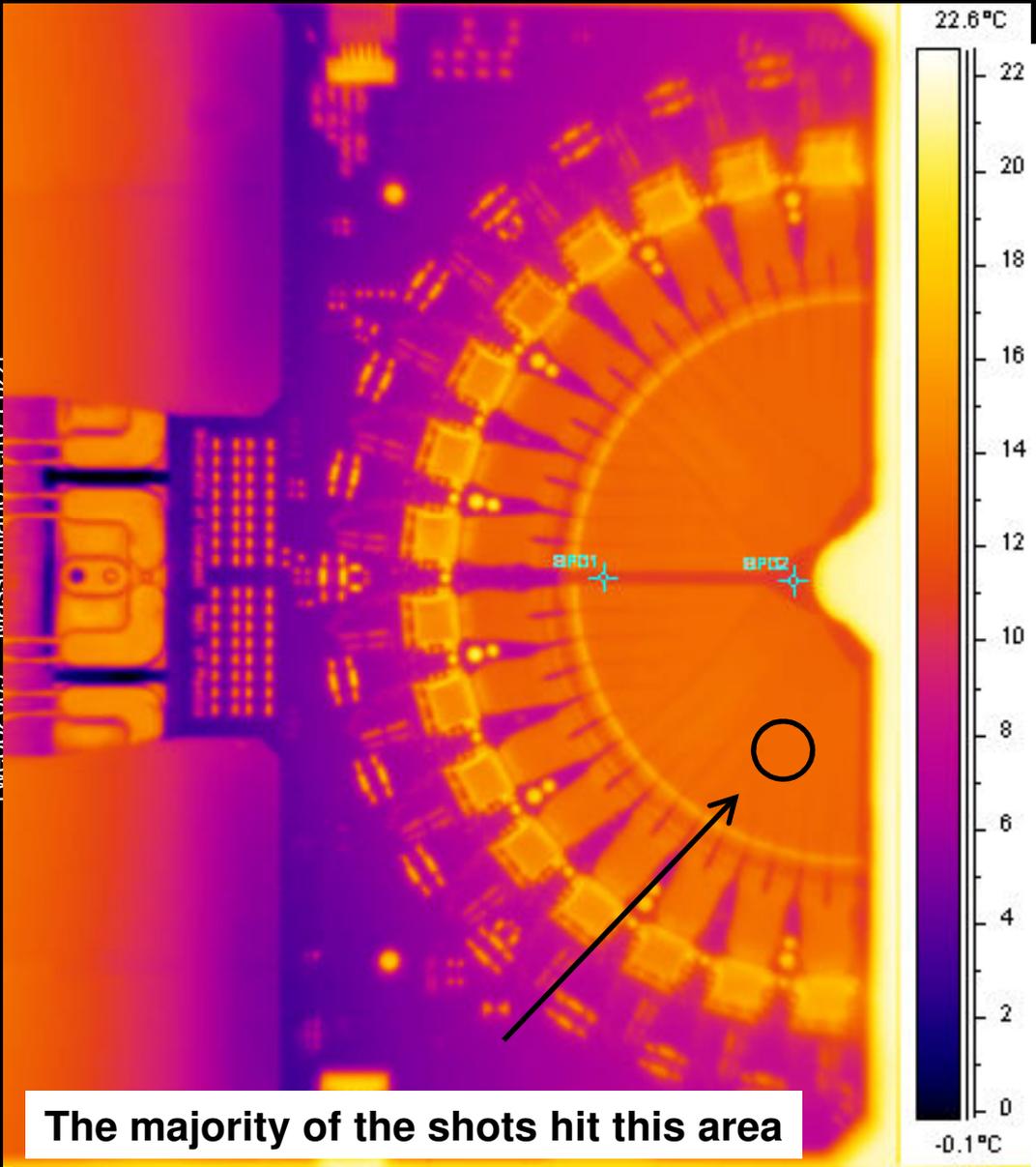
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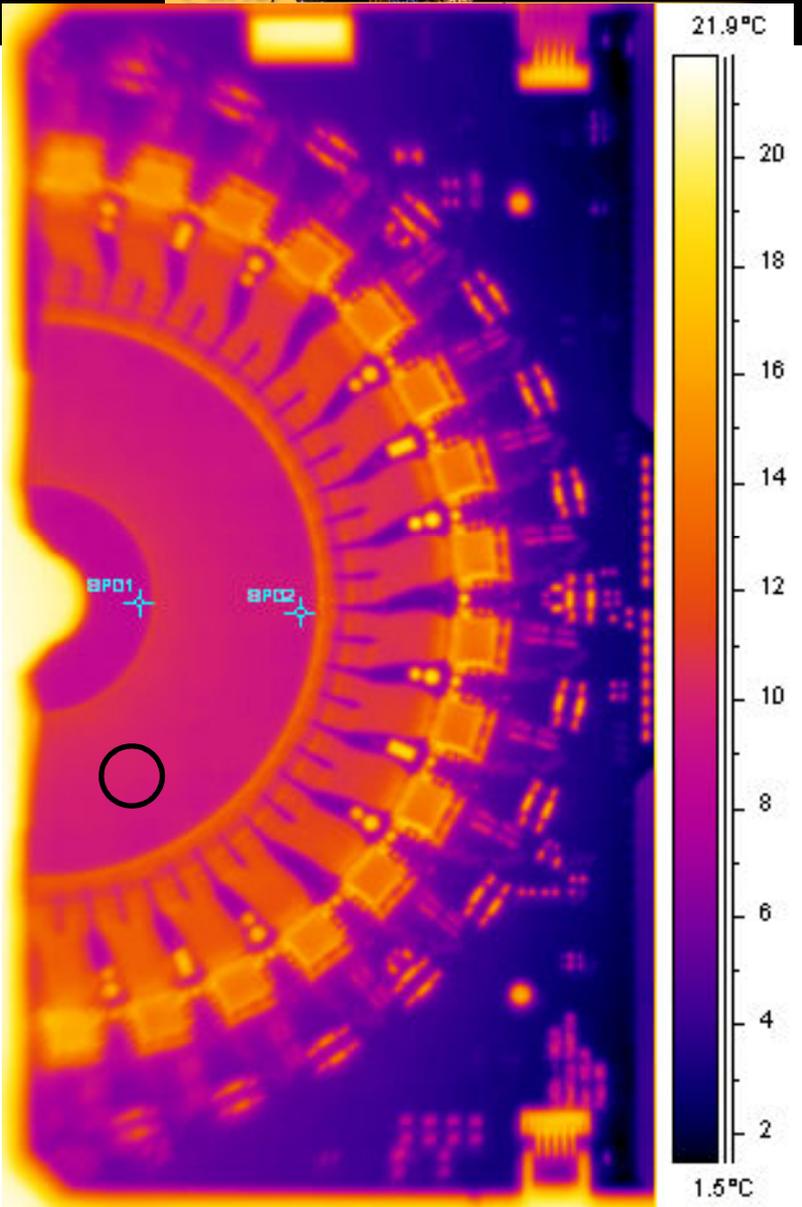
# Thermal image: No hot-spots



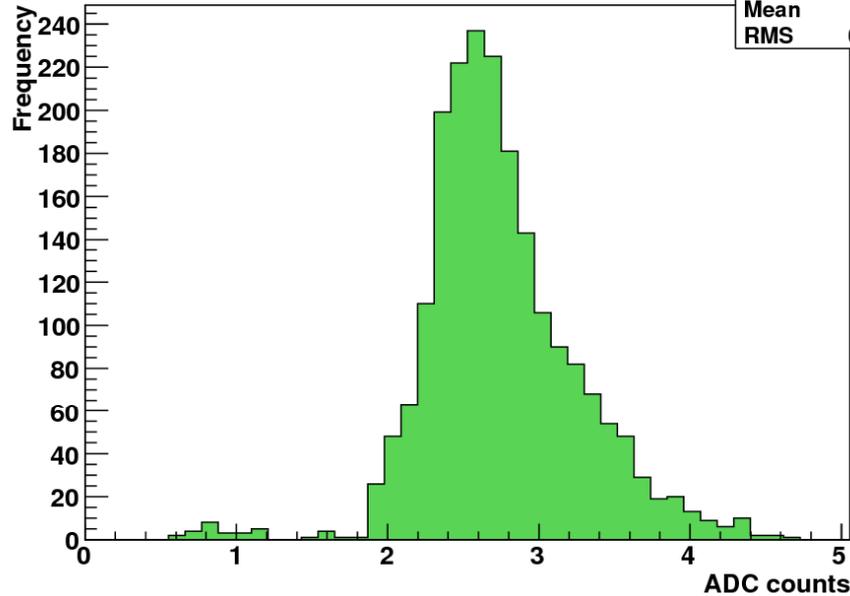
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The majority of the shots hit this area

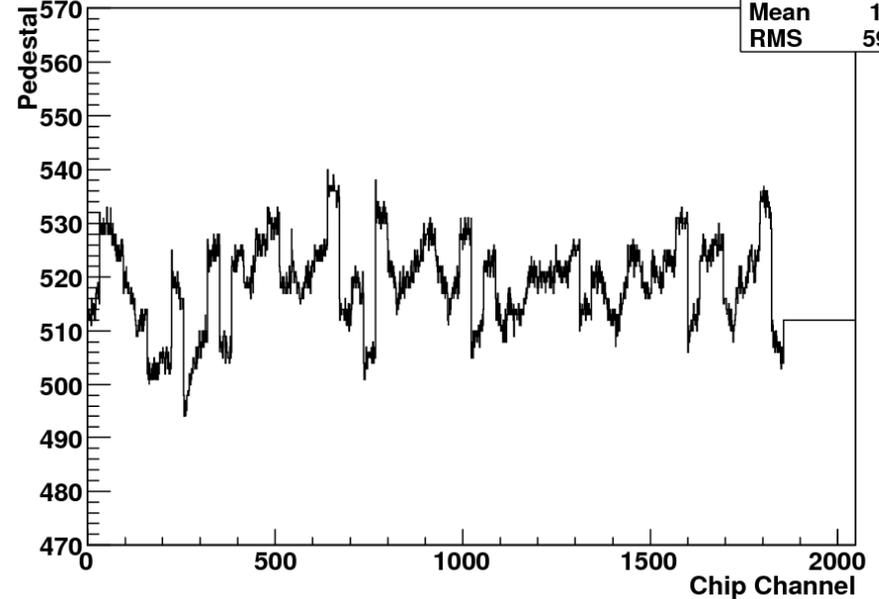


Noise Distribution Tell1 368



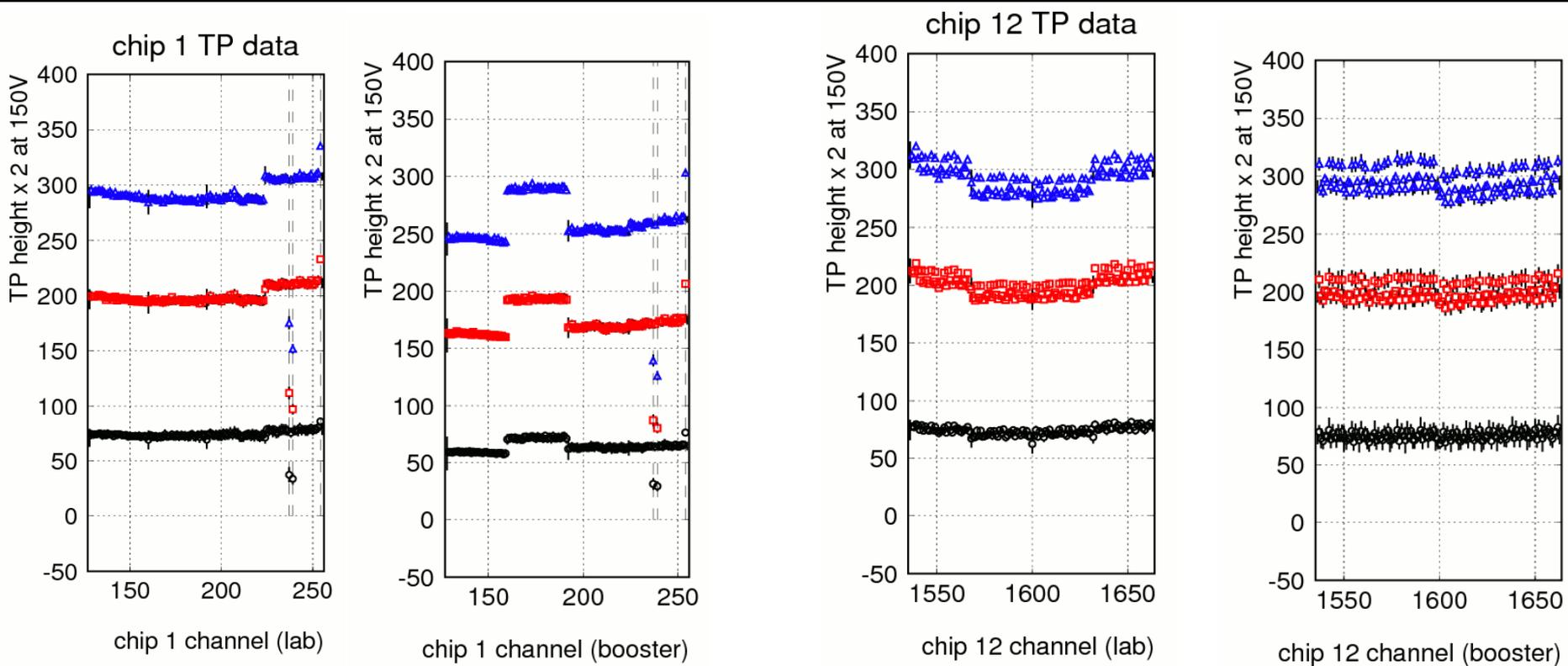
Noise Distribution	
Entries	2048
Mean	2.748
RMS	0.5126

Pedestals Tell1 368

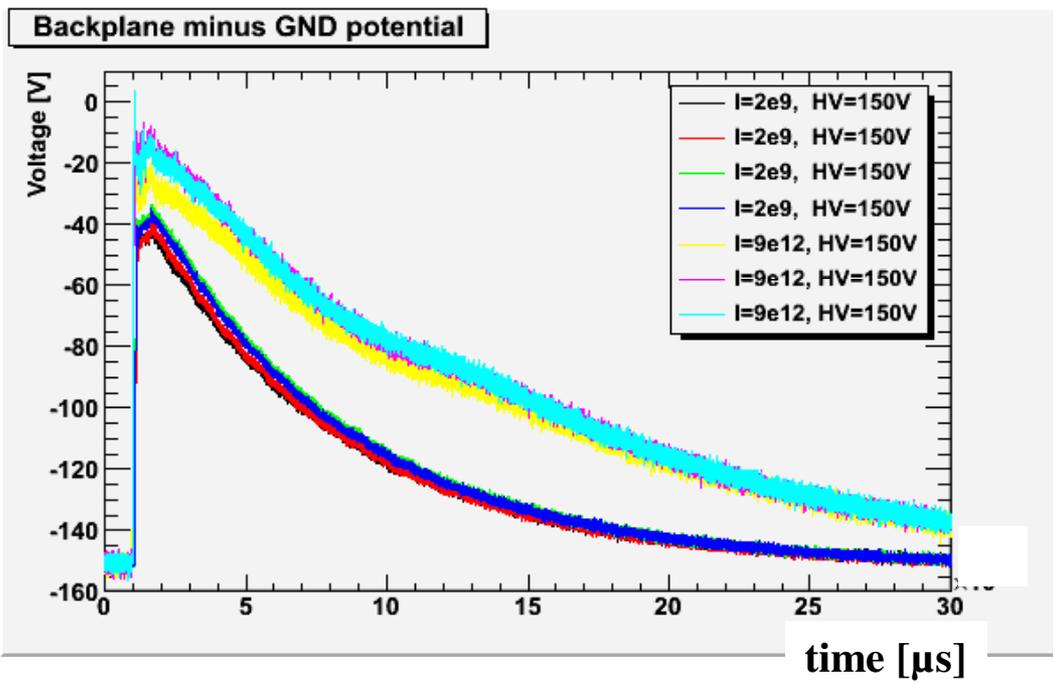


SubtractedPedestals_vs_ChipChannel	
Entries	2048
Mean	1023
RMS	590.2

- ❑ Noise & pedestals measured in-situ between each shot
  - Plots show date taken towards the end of the program
  - No change visible
- ❑ Detailed analysis is in progress



- ❑ **Test pulse response**
  - ‘booster’: in-situ after a couple shots (module almost fresh)
  - ‘lab’: lab measurement after the full program
- ❑ **Gain difference due to different analogue drivers/receivers**
- ❑ **Bad channels identical to production QA**
- ❑ **No significant effect observed due to beam shots**



- Oscilloscope measurements
  - Hybrid GND
  - Backplane
  - 1 sample / ns
- Ground reference arbitrary
  - Huge ground bounce
  - Large pick-up
  - Plot  $V_{backplane} - V_{hybridGND}$
- Two distinct features
  - Sharp rising edge (50 ns)
  - Slow charge-up

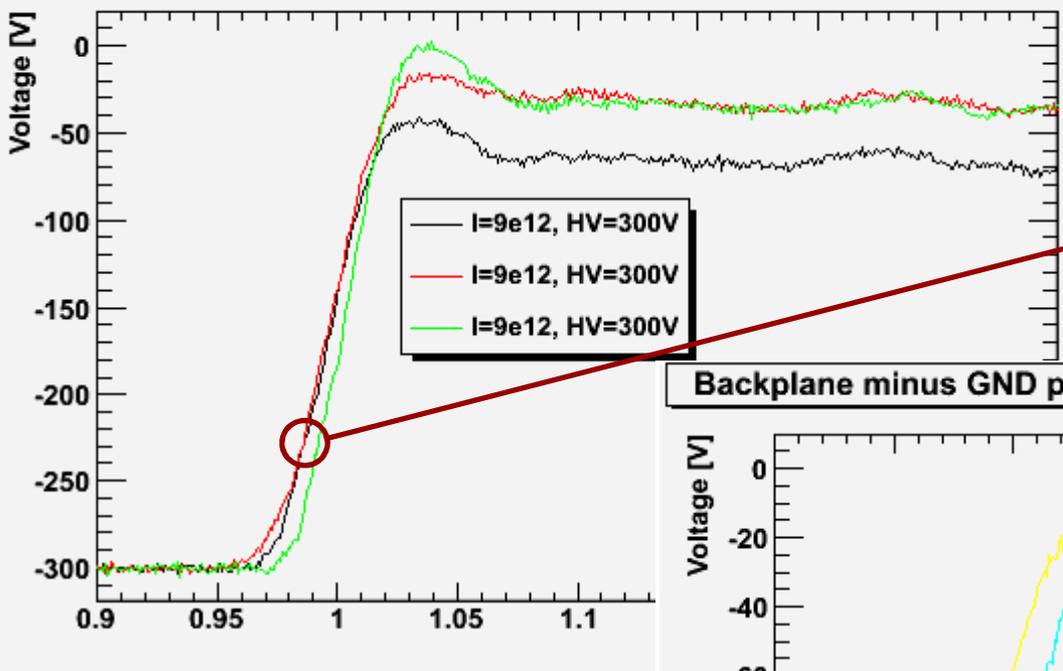


# The first 50 ns ...



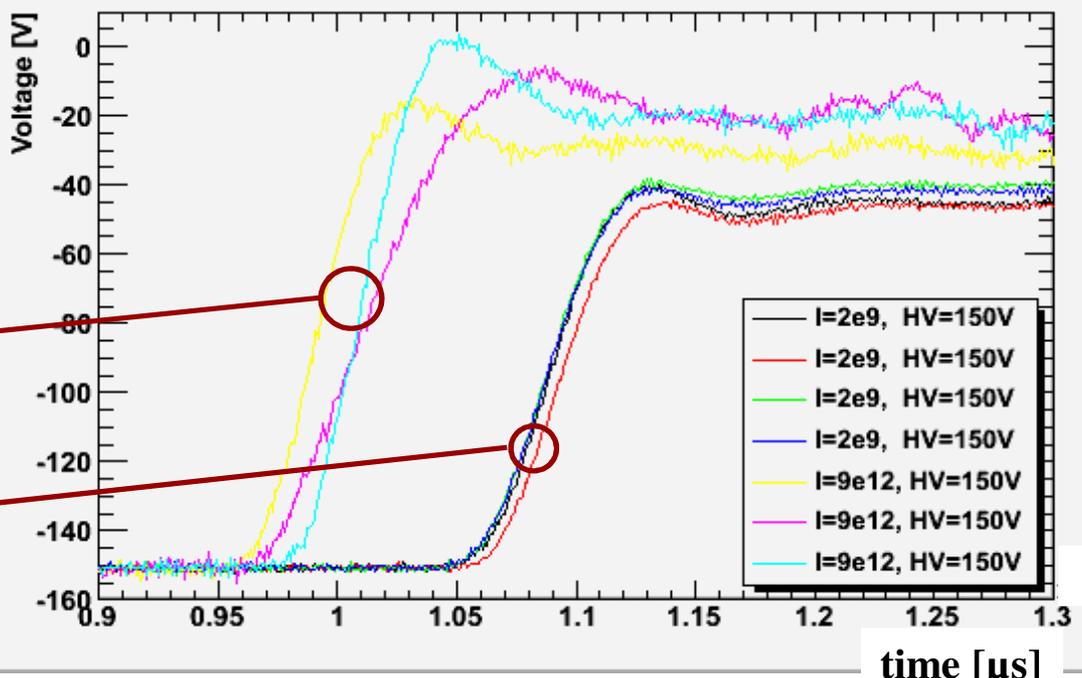
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### Backplane minus GND potential



6 GV/s

### Backplane minus GND potential



2.5 GV/s

2 GV/s

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- ❑ 56 shots on the FE chips:  $2 \times 10^9 - 2 \times 10^{11}$  p/bunch
  
- ❑ No destructive latch-up
  - Design rules include structures to prevent latch-up
  - Seems to be effective!
  
- ❑ SEU analysis in progress: none observed so far
  - Requires large energy deposited in small volume
  - Nuclear reactions necessary
  - Cross-section very low
  - Triple-redundant registers: corrected every 2 ns

- ❑ The PS booster provided beam to emulate specific LHC beam injection failures
  - 200 ns shots ( $\pm 2$  rms),  $2 \times 10^9$  to  $9 \times 10^{12}$  protons in  $\sim 1 \text{ cm}^2$
- ❑ A VELO strip module was subject to a large number of shots
  - Two positions on the sensor, five FE chips
  - Different conditions on LV and HV
- ❑ Survived  $9 \times 10^{12}$   $p$  on sensor with 0, 150, 300 V bias, LV on or off
- ❑ Survived  $2 \times 10^{11}$   $p$  on the FE chip (LV on or off)
- ❑ No visible change in performance
  - I/V curves, noise, pedestals, thermal imaging, ...
- ❑ Saving graces ?
  - The whole sensor responds as a unit
  - Large area sensor – many channels
  - $C_{AC} \gg C_{RC} (+C_{DET})$
  - Protection diodes on the FE inputs
  - Triple-redundant registers in FE chips
- ❑ Analysis & measurement still in progress

- ❑ LHC is very different from what has been seen so far:
  - new (total beam) energy domain
  - cannot run without collimation (cryo/quenches)
- ❑ Machine protection will play a key role (especially at turn-on)
  - passive (collimators) , active (beam interlocks, dump/inject)
- ❑ Expts have developed own (to some extent, common) protection system
  - Beam Conditions Monitor (CVD diamonds) + other detectors => dump trigger
  - Should take care of circulating beam failures (redundant with machine protection)
  - Must have high availability, reliability, efficiency
  - Feed-back to stop injection is implemented
  - Close collaboration with machine colleagues
- ❑ Not all possible failure scenarios for all IP's have been simulated or studied
- ❑ Not all exposed detectors have been stress-tested with high particle rates...
  - Showed some recent results on LHCb/VELO damage threshold
- ❑ Full chain tests ongoing (some already done)
- ❑ Thresholds to be set and fine tuned with beam

 **Work in progress**

- Deposited energy (in 300  $\mu\text{m}$  Si)
    - $9 \times 10^{12} \times 24000 \times 3.6 \text{ eV} \Rightarrow 0.12 \text{ Joule}$  in  $\sim 200 \text{ ns}$
    - Temperature increase in  $1 \text{ cm}^2 \times 0.3 \text{ mm}$  Si  $< \sim 2 \text{ }^\circ\text{C}$
    - Maximum SPS injection train ( $288 \times 10^{11}$ ):  $0.4 \text{ Joule} / 10 \mu\text{s}$
  - Local energy store: the RC filter
    - $10 \text{ nF} @ 300\text{V} \Rightarrow 0.5 \text{ mJ}$
    - Absorption volume critical
  - Massive ionisation in biased silicon
    - $Q_{\text{RC}}(300\text{V}) = 3 \mu\text{C}$
    - Deposited charge @  $2 \times 10^9$ :  $7.5 \mu\text{C}$
  - Possible transient damage
    - Current through front-end
    - AC coupling diode
    - Voltage on front-end input
    - Fast HV ramp-down
- } HV bias reduced to 0 V